

## AWR6843 Single-Chip 60- to 64-GHz mmWave Sensor

## 1 Features

- FMCW transceiver
  - Integrated PLL, transmitter, receiver, Baseband, and A2D
  - 60- to 64-GHz coverage with 4-GHz continuous bandwidth
  - Four receive channels
  - Three transmit channels
  - Supports 6-bit phase shifter
  - Ultra-accurate chirp engine based on fractional-N PLL
  - TX power: 12 dBm
  - RX noise figure:
    - 12 dB
  - Phase noise at 1 MHz:
    - –93 dBc/Hz
- Built-in calibration and self-test
  - ARM<sup>®</sup> Cortex<sup>®</sup>-R4F-based radio control system
  - Built-in firmware (ROM)
  - Self-calibrating system across frequency and temperature
  - Embedded self-monitoring with no host processor involvement on Functional Safety-Compliant targeted devices
- C674x DSP for advanced signal processing
- Hardware accelerator for FFT, filtering, and CFAR processing
- Memory compression
- ARM-R4F microcontroller for object detection, and interface control
  - Supports autonomous mode (loading user application from QSPI flash memory)
- Internal memory with ECC
  - 1.75 MB, divided into MSS program RAM (512 KB), MSS data RAM (192 KB), DSP L1RAM (64KB) and L2 RAM (256 KB), and L3 radar data cube RAM (768 KB)
  - Technical reference manual includes allowed size modifications

- Other interfaces available to user application •
  - Up to 6 ADC channels (low sample rate monitoring)
  - Up to 2 SPI ports
  - Up to 2 UARTs
  - 2 CAN-FD interfaces
  - I2C
  - GPIOs
  - 2 lane LVDS interface for raw ADC data and debug instrumentation
  - Functional Safety-Compliant targeted
    - Developed for functional safety applications
    - Documentation will be available to aid ISO 26262 functional safety system design
    - Hardware integrity up to ASIL-B targeted
    - Safety-related certification ISO 26262 certification by TUV Sud planned
- Non-Functional safety variants
- AEC-Q100 qualified
- Power management
  - Built-in LDO network for enhanced PSRR
  - I/Os support dual voltage 3.3 V/1.8 V
- Clock source
  - 40.0 MHz crystal with internal oscillator
  - Supports external oscillator at 40 MHz
  - Supports externally driven clock (square/sine) at 40 MHz
- Easy hardware design
  - 0.65-mm pitch, 161-pin 10.4 mm × 10.4 mm flip chip BGA package for easy assembly and lowcost PCB design
  - Small solution size
- Supports automotive temperature operating range





## **2** Applications

- Interior Cabin sensing
- Child presence detection
- Occupancy detection
- Seat belt reminder

## **3 Description**

The AWR6843 is an integrated single chip mmWave sensor based on FMCW radar technology capable of operation in the 60-GHz to 64-GHz band. It is built with TI's low power45-nm RFCMOS process and enables unprecedented levels of integration in an extremely small formfactor. The AWR6843 is an ideal solution for low power, self-monitored, ultra-accurate radar systems in the automotive space. Multiple automotive qualified variants are currently available including Functional Safety-Compliant targeted devices and non-functional safety devices.

•

Gesture detection

Driver vital sign monitoring

Kick sensor/access sensor

#### **Device Information**

PART NUMBER	PACKAGE <sup>(1)</sup>	BODY SIZE	TRAY / TAPE AND REEL
AWR6843AQGABLRQ1	FCBGA (161)	10.4 mm × 10.4mm	Tape and Reel (Non-Functional Safety)
AWR6843AQGABLQ1 FCBGA (161) 10.4		10.4 mm × 10.4mm	Tray (Non-Functional Safety)
AWR6843ABGABLRQ1	FCBGA (161)	10.4 mm × 10.4mm	Tape and Reel (Functional Safety-Compliant targeted, ASIL-B)
AWR6843ABGABLQ1	FCBGA (161)	10.4 mm × 10.4mm	Tray (Functional Safety-Compliant targeted, ASIL-B)

(1) For more information, see Section 12, Mechanical, Packaging, and Orderable information.



## **4** Functional Block Diagram

Figure 4-1 shows the functional block diagram of the device.

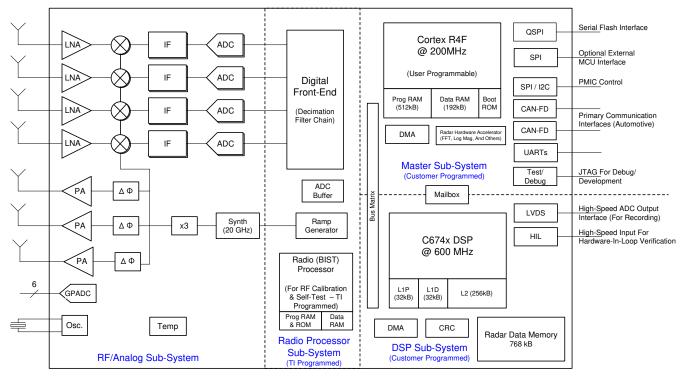


Figure 4-1. Functional Block Diagram



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## **Revision History**

Changes from August 1, 2020 to September 30,	, 2020 (from Revision A (August 2020) to
Revision B (September 2020))	

R	evision B (September 2020))	Page
•	Global: Updated/Changed AWR6843 Functional Safety-Compliant <i>targeted</i> Product Status from "Advanc Information (AI)" to "Production Data (PD)"	
•	Features: Added "Embedded self-monitoring with no host processor involvement on Functional Safety- compliant devices"	1
•	Applications: Changed / Updated link for Interior Cabin Sensing	2
•	Device Information: Added Functional Safety-Compliant targeted production parts AWR6843ABGABLR a AWR6843ABGABL. Removed XA6843ABGABL.	
•	Device Features Comparison: Changed/Updated ASIL-B variant product status to PD	7
•	RF Specification: (RF Specification): Updated/Changed the "1-db Compression Point " footnote	31
•	Section 7.9 (Thermal Resistance Characteristics for FCBGA Package [ABL0161]): Removed "A junction temperature of 105°C is assumed." from footnote	32
•	Section 9.1 (Monitoring and Diagnostic Mechanisms): Added Monitoring and Diagnostic Chapter	63
•	Section 12.2 (Tray Information for ABL, 10.4 × 10.4 mm): Added new section with tray information	72



## Changes from April 30, 2020 to July 31, 2020 (from Revision \* (April 2020) to Revision A (July 2020))

20	020))	Page
•	Global: Updated/Changed the numbering format for tables, figures, and cross-references throughout the	
	document	1
•	Global: Added Non-functional safety variants	1
•	Features: Updated/Changed Phase Noise at 1 MHz from "-92 dBc/Hz" to "-93 dBc/Hz"	1
•	Features: Updated/Changed RX noise figure: from "14 dB " to "12 dB"	1
•	Features: Updated/Changed TX power: from "10 dBm" to "12 dBm"	1
•	Description: Updated description/paragragh	<mark>2</mark>
•	Device Information: Added Non-Functional Safety production parts "AWR6843AQGABLRQ1" part number (PD), "AWR6843AQGABLQ1" part number (PD) and "TRAY / TAPE AND REEL" column	
•	Figure 4-1: Updated block diagram	3
•	Device Features Comparison: Added 2nd column under AWR6843 for non-functional safety variant	7
•	Signal Descriptions: Added Added NOTE about IO pins and GPIO state during power supply ramp	22
•	Recommended Operating Conditions: Updated/Changed MAX value of NRESET SOP [2:0], $V_{IL}$ (1.8V Mo from 0.2 to 0.45 and $V_{IL}$ (3.3V Mode) from 0.3 to 0.65	,
•	Power Supply Specifications: Added " Ripple Specifications" table and the preceeding paragraph. Added table note for Power Supply Rails Characteristics	
•	Power Consumption Summary: Updated Average Power Consumption at Power Terminals and added ta notes.	
•	RF Specification: Updated table Receiver parameters and values	31
•	RF and Analog Subsystem: Updated/Changed section	
•	Transmit Subsystem: Removed "Tx Beam forming applications and interference mitigation" from paragra 59	
•	Processor Subsystem: Updated/Changed figure to include the 2nd CAN instance	60
•	Figure 11-1 Added "AWR = Production Automotive" under Prefix and "Q1 = AEC-Q100" under Qualificati updated/changed the "Features" field to "R = Antenna on Package (AoP)"	



## **5 Device Comparison**

	la	ble 5-1. Devic	e Features Co	mparison	1	1
FUNCTION		AWF	86843	AWR1843	AWR1642	AWR1443
Antenna on	Package (AOP)	—	—	—	—	—
Number of r	eceivers	4	4	4	4	4
Number of ti	ransmitters	3(1)	3 <sup>(1)</sup>	3 <sup>(1)</sup>	2	3
RF frequenc	cy range	60 to 64 GHz	60 to 64 GHz	76 to 81 GHz	76 to 81 GHz	76 to 81 GHz
On-chip mer	nory	1.75MB	1.75MB	2MB	1.5MB	576KB
ASIL		B-Targeted	—	B-Targeted	B-Targeted	
Non-Functio	nal Safety	_	Yes			Yes
Max I/F (Inte	ermediate Frequency) (MHz)	10	10	10	5	5
Max real sar	mpling rate (Msps)	25	25	25	12.5	12.5
Max comple	x sampling rate (Msps)	12.5	12.5	12.5	6.25	6.25
Processors	i	1				
MCU (R4F)		Yes	Yes	Yes	Yes	Yes
DSP (C674x	()	Yes	Yes	Yes	Yes	_
Peripherals	i	1			1	
Serial Periph	neral Interface (SPI) ports	2	2	2	2	1
Quad Serial	Peripheral Interface (QSPI)	Yes	Yes	Yes	Yes	Yes
Inter-Integra	ted Circuit (I <sup>2</sup> C) interface	1	1	1	1	1
Controller A	rea Network (DCAN) interface	_	_	1	1	1
Controller A	rea Network (CAN-FD) interface	2	2	1	_	_
Trace		Yes	Yes	Yes	Yes	_
PWM		Yes	Yes	Yes	Yes	_
Hardware In	Loop (HIL/DMM)	Yes	Yes	Yes	Yes	_
GPADC		Yes	Yes	Yes	Yes	Yes
LVDS/Debu	g	Yes	Yes	Yes	Yes	Yes
CSI2						
Hardware ad	ccelerator	Yes	Yes	Yes	_	Yes
1-V bypass	mode	Yes	Yes	Yes	Yes	Yes
JTAG		Yes	Yes	Yes	Yes	Yes
Product status	Product Preview (PP), Advance Information (AI), or Production Data (PD)	PD <sup>(2)</sup>				

### Table 5-1. Device Features Comparison

(1) 3 Tx Simultaneous operation is supported only with 1-V LDO bypass and PA LDO disable mode. In this mode, the 1-V supply needs to be fed on the VOUT PA pin.

(2) PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of the Texas Instruments standard warranty.



#### **5.1 Related Products**

For information about other devices in this family of products or related products see the links that follow.

mmWave sensors	TI's mmWave sensors rapidly and accurately sense range, angle and velocity with less power using the smallest footprint mmWave sensor portfolio for automotive applications.
Automotive mmWave sensors	TI's automotive mmWave sensor portfolio offers high-performance radar front end to ultra-high resolution, small and low-power single-chip radar solutions. TI's scalable sensor portfolio enables design and development of ADAS system solution for every performance, application and sensor configuration ranging from comfort functions to safety functions in all vehicles.
Companion products for AWR6843	Review products that are frequently purchased or used in conjunction with this product.
Reference designs for AWR6843	TI Designs Reference Design Library is a robust reference design library spanning analog, embedded processor and connectivity. Created by TI experts to help you jump-start your system design, all TI Designs include schematic or block diagrams, BOMs, and design files to speed your time to market. Search and download designs at ti.com/tidesigns.
Vehicle occupant detection reference design	This reference design demonstrates the use of the AWR6843 60GHz single-chip mmWave sensor with integrated DSP, as a Vehicle Occupant Detection (VOD) and Child Presence Detection (CPD) Sensor enabling the detection of life forms in a vehicle. This design provides a reference software processing chain which runs on the C674x DSP, enabling the generation of a heat map to detect occupants in a Field of View (FOV) of $\pm$ 60 degrees.



## **6** Terminal Configuration and Functions

#### 6.1 Pin Diagram

Figure 6-1 shows the pin locations for the 161-pin FCBGA package. Figure 6-2, Figure 6-3, Figure 6-4, and Figure 6-5 show the same pins, but split into four quadrants.

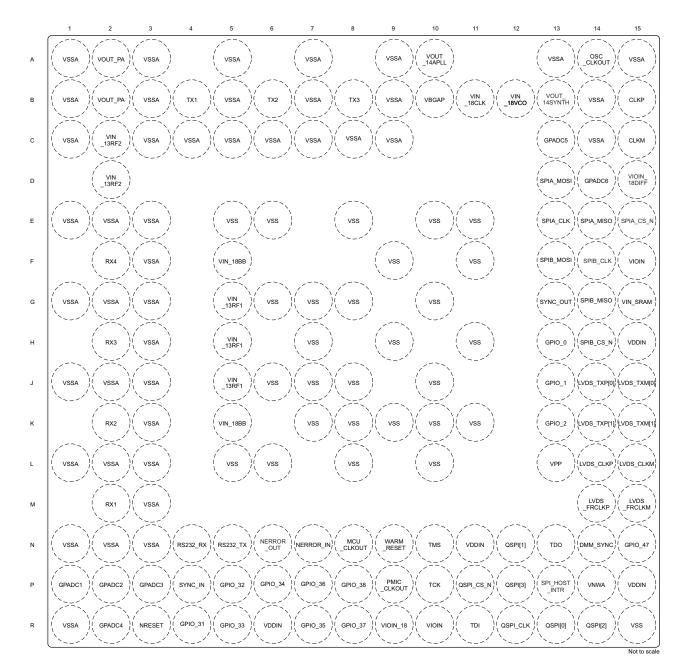
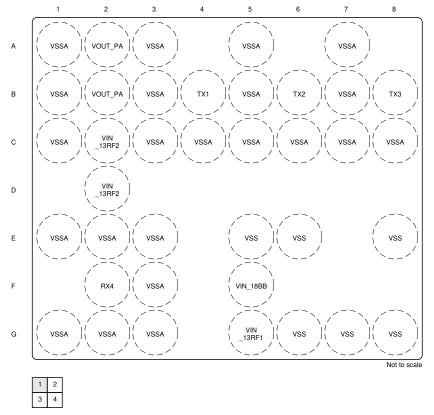


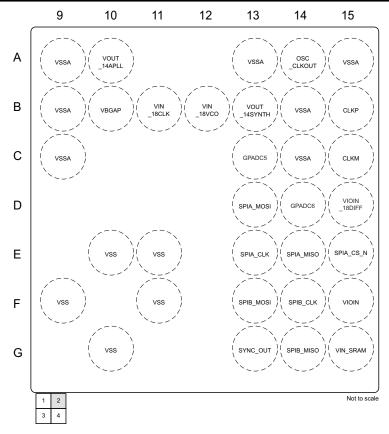
Figure 6-1. Pin Diagram















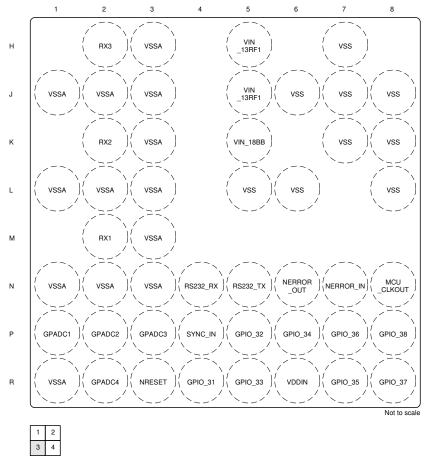


Figure 6-4. Bottom Left Quadrant



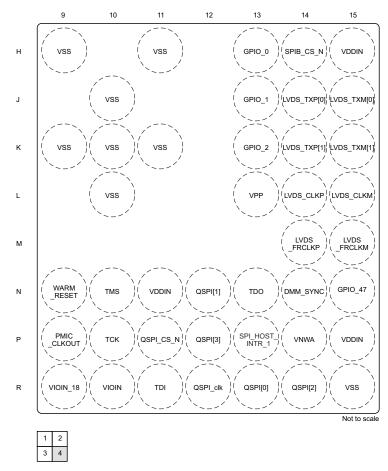


Figure 6-5. Bottom Right Quadrant



#### 6.2 Pin Attributes

#### Table 6-1. Pin Attributes (ABL0161 Package)

BALL NUMBER [1]	BALL NAME [2]	SIGNAL NAME [3]	PINCNTL ADDRESS [4]	MODE [5]	TYPE [6]	BALL RESET STATE [7]	PULL UP/DOWN TYPE [8]
H13	GPIO_0	GPIO_13	0xFFFFEA04	0	10	Output Disabled	Pull Down
		GPIO_0		1	10		
		PMIC_CLKOUT		2	0		
		ADC_VALID		9	0		
		EPWM1B		10	0		
		ePWM2A		11	0		
J13	GPIO_1	GPIO_16	0xFFFFEA08	0	IO	Output Disabled	Pull Down
		GPIO_1		1	10		
		SYNC_OUT		2	0		
		ADC_VALID		7	0		
		DMM_MUX_IN		12	I		
		SPIB_CS_N_1		13	IO		
		SPIB_CS_N_2		14	IO		
		EPWM1SYNCI		15	I		
K13	GPIO_2	GPIO_26	0xFFFFEA64	0	IO	Output Disabled	Pull Down
		GPIO_2		1	ю		
		OSC_CLKOUT		2	0		
		MSS_UARTB_TX		7	0		
		BSS_UART_TX		8	0		
		SYNC_OUT		9	0		
		PMIC_CLKOUT		10	0		
		CHIRP_START		11	0		
		CHIRP_END		12	0		
		FRAME_START		13	0		
R4	GPIO_31	TRACE_DATA_0	0xFFFFEA7C	0	0	Output Disabled	Pull Down
		GPIO_31		1	ю		
		DMM0		2	1		
		MSS_UARTA_TX		4	IO		
P5	GPIO_32	TRACE_DATA_1	0xFFFFEA80	0	0	Output Disabled	Pull Down
		GPIO_32		1	ю		
		DMM1		2	1		
R5	GPIO_33	TRACE_DATA_2	0xFFFFEA84	0	0	Output Disabled	Pull Down
		GPIO_33		1	IO		
		DMM2		2	1	7	
P6	GPIO_34	TRACE_DATA_3	0xFFFFEA88	0	0	Output Disabled	Pull Down
		GPIO_34		1	ю	1	
		DMM3		2	1	1	



R7

BALL NUMBER [1]	BALL NAME [2]	SIGNAL NAME [3]	PINCNTL ADDRESS [4]	MODE [5]	TYPE [6]	BALL RESET STATE [7]	PULL UP/DOWN
		EPWM3SYNCO		4	0		
7	GPIO_35	TRACE_DATA_4	0xFFFFEA8C	0	0	Output Disabled	Pull Down
		GPIO_35		1	10		
		DMM4		2	I		
		EPWM2SYNCO		4	0		
7	GPIO_36	TRACE_DATA_5	0xFFFFEA90	0	0	Output Disabled	Pull Down
		GPIO_36		1	IO	1	
		DMM5		2	I	1	
		MSS_UARTB_TX		5	0		
8	GPIO_37	TRACE_DATA_6	0xFFFFEA94	0	0	Output Disabled	Pull Down
		GPIO_37		1	IO		
		DMM6		2	I		
		BSS_UART_TX		5	0	1	
3	GPIO_38	TRACE_DATA_7	0xFFFFEA98	0	0	Output Disabled	Pull Down
		GPIO_38		1	IO		
		DMM7		2	I	1	
		Dec LIAPT TY		r	0	1	

Table 6-1. Pir	Attributes	(ABL0161	Package)	(continued)	
	Allibules		i achage)	(continucu)	

		DMM4		2	1		
		EPWM2SYNCO		4	0		
7	GPIO_36	TRACE_DATA_5	0xFFFFEA90	0	0	Output Disabled	Pull Down
		GPIO_36		1	IO		
		DMM5		2	1		
		MSS_UARTB_TX		5	0		
.8	GPIO_37	TRACE_DATA_6	0xFFFFEA94	0	0	Output Disabled	Pull Down
		GPIO_37		1	IO		
		DMM6		2	1		
		BSS_UART_TX		5	0		
8	GPIO_38	TRACE_DATA_7	0xFFFFEA98	0	0	Output Disabled	Pull Down
		GPIO_38		1	IO		
		DMM7		2	1		
		DSS_UART_TX		5	0		
15	GPIO_47	TRACE_CLK	0xFFFEABC	0	0	Output Disabled	Pull Down
		GPIO_47		1	IO		
		DMM_CLK		2	1		
14	DMM_SYNC	TRACE_CTL	0xFFFFEAC0	0	0	Output Disabled	Pull Down
		DMM_SYNC		2	1		
8	MCU_CLKOUT	GPIO_25	0xFFFFEA60	0	Ю	Output Disabled	Pull Down
		MCU_CLKOUT		1	0		
		CHIRP_START		2	0		
		CHIRP_END		6	0		
		FRAME_START		7	0		
		EPWM1A		12	0		
7	NERROR_IN	NERROR_IN	0xFFFFEA44	0	1	Input	
6	NERROR_OUT	NERROR_OUT	0xFFFFEA4C	0	0	Hi-Z (Open Drain)	
9	PMIC_CLKOUT	SOP[2]	0xFFFFEA68	During Power Up	I	Output Disabled	Pull Down
		GPIO_27		0	Ю		
		PMIC_CLKOUT		1	0		
		CHIRP_START		6	0		
		CHIRP_END		7	0		
		FRAME_START		8	0		
		EPWM1B		11	0		
		EPWM2A		12	0		

## Table 6-1. Pin Attributes (ABL0161 Package) (continued)

BALL NUMBER [1]	BALL NAME [2]	SIGNAL NAME [3]	PINCNTL ADDRESS [4]	MODE [5]	TYPE [6]	BALL RESET STATE [7]	PULL UP/DOWN TYPE [8]
R13	QSPI[0]	GPIO_8	0xFFFFEA2C	0	IO	Output Disabled	Pull Down
		QSPI[0]		1	10		
		SPIB_MISO		2	IO		
N12	QSPI[1]	GPIO_9	0xFFFFEA30	0	IO	Output Disabled	Pull Down
		QSPI[1]		1	1		
		SPIB_MOSI		2	IO		
		SPIB_CS_N_2		8	IO		
R14	QSPI[2]	GPIO_10	0xFFFFEA34	0	IO	Output Disabled	Pull Down
		QSPI[2]		1	1		
		CAN1_FD_TX		8	0		
P12	QSPI[3]	GPIO_11	0xFFFFEA38	0	IO	Output Disabled	Pull Down
		QSPI[3]		1	1		
		CAN1_FD_RX		8	1		
R12	QSPI_CLK	GPIO_7	0xFFFFEA3C	0	10	Output Disabled	Pull Down
		QSPI_CLK		1	0		
		SPIB_CLK		2	IO		
		DSS_UART_TX		6	0		
P11	QSPI_CS_N	GPIO_6	0xFFFFEA40	0	10	Output Disabled	Pull Up
		QSPI_CS_N		1	0		
		SPIB_CS_N		2	IO		
N4	RS232_RX	GPIO_15	0xFFFFEA74	0	IO	Input Enabled	Pull Up
		RS232_RX		1	1		
		MSS_UARTA_RX		2	1		
		BSS_UART_TX		6	10		
		MSS_UARTB_RX		7	IO		
		CAN1_FD_RX		8	1		
		I2C_SCL		9	IO		
		EPWM2A		10	0		
		EPWM2B		11	0		
		EPWM3A		12	0		
N5	RS232_TX	GPIO_14	0xFFFFEA78	0	IO	Output Enabled	
		RS232_TX		1	0		
		MSS_UARTA_TX		5	IO		
		MSS_UARTB_TX		6	IO		
		BSS_UART_TX		7	IO		
		CAN1_FD_TX		10	0	7	
		I2C_SDA		11	IO	7	
		EPWM1A		12	0	1	
		EPWM1B		13	0	7	



#### Table 6-1. Pin Attributes (ABL0161 Package) (continued)

BALL NUMBER [1]	BALL NAME [2]	SIGNAL NAME [3]	PINCNTL ADDRESS [4]	MODE [5]	TYPE [6]	BALL RESET STATE [7]	PULL UP/DOWN TYPE [8]
		NDMM_EN		14	1		
		EPWM2A		15	0		
E13	SPIA_CLK	GPIO_3	0xFFFFEA14	0	IO	Output Disabled	Pull Up
		SPIA_CLK		1	IO		
		CAN2_FD_RX		6	1		
		DSS_UART_TX		7	0		
E15	SPIA_CS_N	GPIO_30	0xFFFFEA18	0	IO	Output Disabled	Pull Up
		SPIA_CS_N		1	IO		
		CAN2_FD_TX		6	0	Output Disabled	
E14	SPIA_MISO	GPIO_20	0xFFFFEA10	0	IO	Output Disabled	Pull Up
		SPIA_MISO		1	IO		
		CAN1_FD_TX		2	0		
D13	SPIA_MOSI	GPIO_19	0xFFFFEA0C	0	IO	Output Disabled	Pull Up
		SPIA_MOSI		1	IO		
		CAN1_FD_RX		2	1	_	
		DSS_UART_TX		8	0		
F14	SPIB_CLK	GPIO_5	0xFFFFEA24	0	IO	Output Disabled	Pull Up
		SPIB_CLK		1	IO	_	
		MSS_UARTA_RX		2	1	_	
		MSS_UARTB_TX		6	0		
		BSS_UART_TX		7	0		
		CAN1_FD_RX		8	1		
H14	SPIB_CS_N	GPIO_4	0xFFFFEA28	0	10	Output Disabled	Pull Up
		SPIB_CS_N		1	IO	_	
		MSS_UARTA_TX		2	0		
		MSS_UARTB_TX		6	0	_	
		BSS_UART_TX		7	10		
		QSPI_CLK_EXT		8	1		
		CAN1_FD_TX		9	0		
G14	SPIB_MISO	GPIO_22	0xFFFFEA20	0	10	Output Disabled	Pull Up
		SPIB_MISO		1	IO		
		I2C_SCL		2	10		
		DSS_UART_TX		6	0		
F13	SPIB_MOSI	 GPIO_21	0xFFFFEA1C	0	10	Output Disabled	Pull Up
	_	SPIB_MOSI		1	10		
		 I2C_SDA		2	10	-	
P13	SPI_HOST_INTR	 GPIO_12	0xFFFFEA00	0	10	Output Disabled	Pull Down
				1	0	$\neg$	

#### Table 6-1. Pin Attributes (ABL0161 Package) (continued)

BALL NUMBER [1]	BALL NAME [2]	SIGNAL NAME [3]	PINCNTL ADDRESS [4]	MODE [5]	TYPE [6]	BALL RESET STATE [7]	PULL UP/DOWN TYPE [8]
		ADC_VALID		2	0		
		SPIB_CS_N_1		6	IO		
P4	SYNC_IN	GPIO_28	0xFFFFEA6C	0	Ю	Output Disabled	Pull Down
		SYNC_IN		1	I		
		MSS_UARTB_RX		6	10		
		DMM_MUX_IN		7	1		
		SYNC_OUT		9	0	Output Disabled Output Disabled Output Disabled Input Enabled Input Enabled Output Enabled Output Enabled Output Enabled	
G13	SYNC_OUT	SOP[1]	0xFFFFEA70	During Power Up	1	Output Disabled	Pull Down
		GPIO_29		0	10		
		SYNC_OUT		1	0		
		DMM_MUX_IN		9	1		
		SPIB_CS_N_1		10	Ю	_	
		SPIB_CS_N_2		11	Ю		
P10	тск	GPIO_17	0xFFFFEA50	0	Ю	Input Enabled	Pull Down
		тск		1	1		
		MSS_UARTB_TX		2	0		
		CAN1_FD_TX		8	0		
R11	TDI	GPIO_23	0xFFFFEA58	0	IO	Input Enabled	Pull Up
		TDI		1	I		
		MSS_UARTA_RX		2	1		
N13	TDO	SOP[0]	0xFFFFEA5C	During Power Up	I	Output Enabled	
		GPIO_24		0	IO		
		TDO		1	0		
		MSS_UARTA_TX		2	0		
		MSS_UARTB_TX		6	0		
		BSS_UART_TX		7	0		
		NDMM_EN		9	I		
N10	TMS	GPIO_18	0xFFFEA54	0	ю	Input Enabled	Pull Down
		TMS		1	1		
		BSS_UART_TX		2	0		
		CAN1_FD_RX		6	I		
N9	WARM_RESET	WARM_RESET	0xFFFFEA48	0	IO	Hi-Z Input (Open Drain)	

The following list describes the table column headers:

- 1. **BALL NUMBER:** Ball numbers on the bottom side associated with each signal on the bottom.
- 2. BALL NAME: Mechanical name from package device (name is taken from muxmode 0).
- 3. SIGNAL NAME: Names of signals multiplexed on each ball (also notice that the name of the ball is the signal name in muxmode 0).



- 4. PINCNTL ADDRESS: MSS Address for PinMux Control
- 5. **MODE:** Multiplexing mode number: value written to PinMux Cntl register to select specific Signal name for this Ball number. Mode column has bit range value.
- 6. **TYPE:** Signal type and direction:
  - I = Input
  - O = Output
  - IO = Input or Output
- 7. BALL RESET STATE: The state of the terminal after supplies are stable after power-on-reset (NRESET) is asserted
- 8. **PULL UP/DOWN TYPE:** indicates the presence of an internal pullup or pulldown resistor. Pullup and pulldown resistors can be enabled or disabled via software.
  - Pull Up: Internal pullup
  - Pull Down: Internal pulldown
  - An empty box means No pull.
- 9. Pin Mux Control Value maps to lower 4 bits of register.



IO MUX registers are available in the MSS memory map and the respective mapping to device pins is as follows:

Default Pin/Ball Name	Package Ball /Pin (Address)	Pin Mux Config Register
SPI_HOST_INTR	P13	0xFFFEA00
 GPIO_0	H13	0xFFFEA04
 GPIO_1	J13	0xFFFFEA08
SPIA_MOSI	D13	0xFFFEA0C
	E14	0xFFFEA10
SPIA_CLK	E13	0xFFFEA14
SPIA_CS_N	E15	0xFFFFEA18
SPIB_MOSI	F13	0xFFFFEA1C
SPIB_MISO	G14	0xFFFFEA20
SPIB_CLK	F14	0xFFFFEA24
SPIB_CS_N	H14	0xFFFFEA28
QSPI[0]	R13	0xFFFFEA2C
QSPI[1]	N12	0xFFFFEA30
QSPI[2]	R14	0xFFFFEA34
QSPI[3]	P12	0xFFFFEA38
QSPI_CLK	R12	0xFFFFEA3C
QSPI_CS_N	P11	0xFFFFEA40
NERROR_IN	N7	0xFFFEA44
WARM_RESET	N9	0xFFFEA48
NERROR_OUT	N6	0xFFFEA4C
ТСК	P10	0xFFFEA50
TMS	N10	0xFFFEA54
TDI	R11	0xFFFEA58
TDO	N13	0xFFFEA5C
MCU_CLKOUT	N8	0xFFFEA60
GPIO_2	K13	0xFFFEA64
PMIC_CLKOUT	P9	0xFFFEA68
SYNC_IN	P4	0xFFFEA6C
SYNC_OUT	G13	0xFFFEA70
RS232_RX	N4	0xFFFEA74
RS232_TX	N5	0xFFFEA78



Table 6-2. PAD IO Control Registers (continued)						
Default Pin/Ball Name	Package Ball /Pin (Address)	Pin Mux Config Register				
GPIO_31	R4	0xFFFFEA7C				
GPIO_32	P5	0xFFFFEA80				
GPIO_33	R5	0xFFFFEA84				
GPIO_34	P6	0xFFFFEA88				
GPIO_35	R7	0xFFFFEA8C				
GPIO_36	P7	0xFFFFEA90				
GPIO_37	R8	0xFFFEA94				
GPIO_38	P8	0xFFFEA98				
GPIO_47	N15	0xFFFEABC				
DMM_SYNC	N14	0xFFFFEAC0				

The register layout is as follows:

#### Table 6-3. PAD IO Register Bit Descriptions

BIT	FIELD	ТҮРЕ	RESET (POWER ON DEFAULT)	DESCRIPTION
31-11	NU	RW	0	Reserved
10	SC	RW	0	IO slew rate control: 0 = Higher slew rate 1 = Lower slew rate
9	PUPDSEL	RW	0	Pullup/PullDown Selection 0 = Pull Down 1 = Pull Up (This field is valid only if Pull Inhibit is set as '0')
8	PI	RW	0	Pull Inhibit/Pull Disable 0 = Enable 1 = Disable
7	OE_OVERRIDE	RW	1	Output Override
6	OE_OVERRIDE_CTRL	RW	1	Output Override Control: (A '1' here overrides any o/p manipulation of this IO by any of the peripheral block hardware it is associated with for example a SPI Chip select)
5	IE_OVERRIDE	RW	0	Input Override
4	IE_OVERRIDE_CTRL	RW	0	Input Override Control: (A '1' here overrides any i/p value on this IO with a desired value)
3-0	FUNC_SEL	RW	1	Function select for Pin Multiplexing (Refer to the Pin Mux Sheet)



#### 6.3 Signal Descriptions

#### Note

All IO pins of the device (except NERROR IN, NERROR\_OUT, and WARM\_RESET) are non-failsafe; hence, care needs to be taken that they are not driven externally without the VIO supply being present to the device.

#### Note

The GPIO state during the power supply ramp is not ensured. In case the GPIO is used in the application where the state of the GPIO is critical, even when NRESET is low , a tri-state buffer should be used to isolate the GPIO output from the radar device and a pull resister used to define the required state in the application. The NRESET signal to the radar device could be used to control the output enable (OE) of the tri-state buffer.

#### 6.3.1 Signal Descriptions - Digital

SIGNAL NAME	PIN TYPE	DESCRIPTION	BALL NO.
BSS_UART_TX	0	Debug UART Transmit [Radar Block]	F14, H14, K13, N10, N13, N4, N5, R8
CAN1_FD_RX	I	CAN1 FD (MCAN) Receive Signal	D13, F14, N10, N4, P12
CAN1_FD_TX	0	CAN1 FD (MCAN) Transmit Signal	E14, H14, N5, P10, R14
CAN2_FD_RX	I	CAN2 FD (MCAN) Receive Signal	E13
CAN2_FD_TX	IO	CAN2 FD (MCAN) Transmit Signal	E15
DMM0	I	Debug Interface (Hardware In Loop) - Data Line	R4
DMM1	I	Debug Interface (Hardware In Loop) - Data Line	P5
DMM2	I	Debug Interface (Hardware In Loop) - Data Line	R5
DMM3	I	Debug Interface (Hardware In Loop) - Data Line	P6
DMM4	I	Debug Interface (Hardware In Loop) - Data Line	R7
DMM5	I	Debug Interface (Hardware In Loop) - Data Line	P7
DMM6	I	Debug Interface (Hardware In Loop) - Data Line	R8
DMM7	I	Debug Interface (Hardware In Loop) - Data Line	P8
DMM_CLK	I	Debug Interface (Hardware In Loop) - Clock	N15
DMM_MUX_IN	I	Debug Interface (Hardware In Loop) Mux Select between DMM1 and DMM2 (Two Instances)	G13, J13, P4
DMM_SYNC	I	Debug Interface (Hardware In Loop) - Sync	N14
DSS_UART_TX	0	Debug UART Transmit [DSP]	D13, E13, G14, P8, R12
EPWM1A	0	PWM Module 1 - Output A	N5, N8
EPWM1B	0	PWM Module 1 - Output B	H13, N5, P9
EPWM1SYNCI	I		J13
EPWM2A	0	PWM Module 2- Output A	H13, N4, N5, P9
EPWM2B	0	PWM Module 2 - Output B	N4
EPWM2SYNCO	0		R7
EPWM3A	0	PWM Module 3 - Output A	N4
EPWM3SYNCO	0		P6
GPIO_0	IO	General-purpose I/O	H13
GPIO_1	IO	General-purpose I/O	J13
GPIO_2	IO	General-purpose I/O	K13
GPIO_3	IO	General-purpose I/O	E13
GPIO_4	IO	General-purpose I/O	H14
GPIO_5	IO	General-purpose I/O	F14



SIGNAL NAME         PIN TYPE         DESCRIPTION         BALL NO.           GPIO_6         IO         General-purpose I/O         P11           GPIO_7         IO         General-purpose I/O         R12           GPIO_9         IO         General-purpose I/O         R13           GPIO_10         IO         General-purpose I/O         R13           GPIO_11         IO         General-purpose I/O         P12           GPIO_12         IO         General-purpose I/O         P13           GPIO_13         IO         General-purpose I/O         N4           GPIO_14         IO         General-purpose I/O         N4           GPIO_15         IO         General-purpose I/O         N4           GPIO_16         IO         General-purpose I/O         N4           GPIO_17         IO         General-purpose I/O         N4           GPIO_18         IO         General-purpose I/O         N13           GPIO_20         IO         General-purpose I/O         S13           GPIO_21         IO         General-purpose I/O         S14           GPIO_22         IO         General-purpose I/O         S14           GPIO_22         IO         General-purpose I/O
GPIO_7         IO         General-purpose I/O         R12           GPIO_8         IO         General-purpose I/O         R13           GPIO_9         IO         General-purpose I/O         R14           GPIO_10         IO         General-purpose I/O         R14           GPIO_11         IO         General-purpose I/O         P12           GPIO_12         IO         General-purpose I/O         P13           GPIO_13         IO         General-purpose I/O         N5           GPIO_14         IO         General-purpose I/O         N4           GPIO_15         IO         General-purpose I/O         N4           GPIO_16         IO         General-purpose I/O         N4           GPIO_17         IO         General-purpose I/O         N4           GPIO_18         IO         General-purpose I/O         N10           GPIO_21         IO         General-purpose I/O         D13           GPIO_22         IO         General-purpose I/O         E14           GPIO_23         IO         General-purpose I/O         R11           GPIO_24         IO         General-purpose I/O         N13           GPIO_25         IO         General-purpose I/O         <
GPIO_8         IO         General-purpose I/O         R13           GPIO_9         IO         General-purpose I/O         N12           GPIO_10         IO         General-purpose I/O         R14           GPIO_11         IO         General-purpose I/O         P12           GPIO_12         IO         General-purpose I/O         P13           GPIO_13         IO         General-purpose I/O         N5           GPIO_14         IO         General-purpose I/O         N4           GPIO_15         IO         General-purpose I/O         N4           GPIO_16         IO         General-purpose I/O         N13           GPIO_17         IO         General-purpose I/O         P10           GPIO_18         IO         General-purpose I/O         P10           GPIO_20         IO         General-purpose I/O         D13           GPIO_21         IO         General-purpose I/O         E14           GPIO_22         IO         General-purpose I/O         G14           GPIO_23         IO         General-purpose I/O         R11           GPIO_24         IO         General-purpose I/O         N13           GPIO_25         IO         General-purpose I/O
GPIO_9         IO         General-purpose I/O         N12           GPIO_10         IO         General-purpose I/O         R14           GPIO_11         IO         General-purpose I/O         P12           GPIO_12         IO         General-purpose I/O         P13           GPIO_13         IO         General-purpose I/O         H13           GPIO_14         IO         General-purpose I/O         N5           GPIO_15         IO         General-purpose I/O         N4           GPIO_16         IO         General-purpose I/O         N13           GPIO_17         IO         General-purpose I/O         N10           GPIO_18         IO         General-purpose I/O         N10           GPIO_20         IO         General-purpose I/O         N10           GPIO_21         IO         General-purpose I/O         S13           GPIO_22         IO         General-purpose I/O         S14           GPIO_23         IO         General-purpose I/O         S14           GPIO_24         IO         General-purpose I/O         R11           GPIO_25         IO         General-purpose I/O         N13           GPIO_26         IO         General-purpose I/O
GPIO_10         IO         General-purpose I/O         R14           GPIO_11         IO         General-purpose I/O         P12           GPIO_12         IO         General-purpose I/O         P13           GPIO_13         IO         General-purpose I/O         N5           GPIO_14         IO         General-purpose I/O         N5           GPIO_15         IO         General-purpose I/O         N4           GPIO_16         IO         General-purpose I/O         N4           GPIO_17         IO         General-purpose I/O         N13           GPIO_18         IO         General-purpose I/O         N10           GPIO_19         IO         General-purpose I/O         N10           GPIO_20         IO         General-purpose I/O         D13           GPIO_21         IO         General-purpose I/O         E14           GPIO_22         IO         General-purpose I/O         R11           GPIO_23         IO         General-purpose I/O         R11           GPIO_24         IO         General-purpose I/O         N13           GPIO_25         IO         General-purpose I/O         N13           GPIO_26         IO         General-purpose I/O
GPIO_111         IO         General-purpose I/O         P12           GPIO_12         IO         General-purpose I/O         P13           GPIO_13         IO         General-purpose I/O         H13           GPIO_14         IO         General-purpose I/O         N5           GPIO_15         IO         General-purpose I/O         N4           GPIO_16         IO         General-purpose I/O         N4           GPIO_17         IO         General-purpose I/O         N10           GPIO_18         IO         General-purpose I/O         N10           GPIO_19         IO         General-purpose I/O         D13           GPIO_20         IO         General-purpose I/O         F13           GPIO_21         IO         General-purpose I/O         G14           GPIO_22         IO         General-purpose I/O         R11           GPIO_23         IO         General-purpose I/O         R11           GPIO_24         IO         General-purpose I/O         N13           GPIO_25         IO         General-purpose I/O         N13           GPIO_26         IO         General-purpose I/O         N13           GPIO_28         IO         General-purpose I/O
GPIO_12         IO         General-purpose I/O         P13           GPIO_13         IO         General-purpose I/O         H13           GPIO_14         IO         General-purpose I/O         N5           GPIO_15         IO         General-purpose I/O         N4           GPIO_16         IO         General-purpose I/O         J13           GPIO_17         IO         General-purpose I/O         P10           GPIO_18         IO         General-purpose I/O         D13           GPIO_21         IO         General-purpose I/O         E14           GPIO_21         IO         General-purpose I/O         F13           GPIO_22         IO         General-purpose I/O         F13           GPIO_23         IO         General-purpose I/O         G14           GPIO_24         IO         General-purpose I/O         N13           GPIO_25         IO         General-purpose I/O         N13           GPIO_26         IO         General-purpose I/O         N13           GPIO_27         IO         General-purpose I/O         N8           GPIO_28         IO         General-purpose I/O         R11           GPIO_29         IO         General-purpose I/O
GPIO_13         IO         General-purpose I/O         H13           GPIO_14         IO         General-purpose I/O         N5           GPIO_15         IO         General-purpose I/O         N4           GPIO_16         IO         General-purpose I/O         J13           GPIO_17         IO         General-purpose I/O         P10           GPIO_18         IO         General-purpose I/O         N10           GPIO_20         IO         General-purpose I/O         E14           GPIO_21         IO         General-purpose I/O         E14           GPIO_22         IO         General-purpose I/O         F13           GPIO_23         IO         General-purpose I/O         R11           GPIO_24         IO         General-purpose I/O         R11           GPIO_25         IO         General-purpose I/O         N13           GPIO_26         IO         General-purpose I/O         N13           GPIO_27         IO         General-purpose I/O         N8           GPIO_28         IO         General-purpose I/O         P9           GPIO_28         IO         General-purpose I/O         P4           GPIO_29         IO         General-purpose I/O
GPIO_14         IO         General-purpose I/O         N5           GPIO_15         IO         General-purpose I/O         N4           GPIO_16         IO         General-purpose I/O         J13           GPIO_17         IO         General-purpose I/O         P10           GPIO_18         IO         General-purpose I/O         N10           GPIO_19         IO         General-purpose I/O         D13           GPIO_20         IO         General-purpose I/O         E14           GPIO_21         IO         General-purpose I/O         F13           GPIO_22         IO         General-purpose I/O         R11           GPIO_23         IO         General-purpose I/O         R11           GPIO_24         IO         General-purpose I/O         N13           GPIO_25         IO         General-purpose I/O         N13           GPIO_26         IO         General-purpose I/O         N13           GPIO_28         IO         General-purpose I/O         N43           GPIO_28         IO         General-purpose I/O         P4           GPIO_29         IO         General-purpose I/O         C13           GPIO_30         IO         General-purpose I/O
GPI0_15         IO         General-purpose I/O         N4           GPI0_16         IO         General-purpose I/O         J13           GPI0_17         IO         General-purpose I/O         P10           GPI0_18         IO         General-purpose I/O         N10           GPI0_19         IO         General-purpose I/O         D13           GPI0_20         IO         General-purpose I/O         E14           GPI0_21         IO         General-purpose I/O         F13           GPI0_22         IO         General-purpose I/O         G14           GPI0_23         IO         General-purpose I/O         R11           GPI0_24         IO         General-purpose I/O         R11           GPI0_25         IO         General-purpose I/O         N13           GPI0_25         IO         General-purpose I/O         N13           GPI0_26         IO         General-purpose I/O         N8           GPI0_27         IO         General-purpose I/O         R13           GPI0_28         IO         General-purpose I/O         G13           GPI0_30         IO         General-purpose I/O         G13           GPI0_31         IO         General-purpose I/O
GPI0_16         IO         General-purpose I/O         J13           GPI0_17         IO         General-purpose I/O         P10           GPI0_18         IO         General-purpose I/O         N10           GPI0_19         IO         General-purpose I/O         D13           GPI0_20         IO         General-purpose I/O         E14           GPI0_21         IO         General-purpose I/O         F13           GPI0_22         IO         General-purpose I/O         G14           GPI0_23         IO         General-purpose I/O         R11           GPI0_24         IO         General-purpose I/O         N13           GPI0_25         IO         General-purpose I/O         N13           GPI0_26         IO         General-purpose I/O         N13           GPI0_25         IO         General-purpose I/O         N13           GPI0_26         IO         General-purpose I/O         N8           GPI0_28         IO         General-purpose I/O         R13           GPI0_29         IO         General-purpose I/O         G13           GPI0_30         IO         General-purpose I/O         G13           GPI0_31         IO         General-purpose I/O
GPI0_17         IO         General-purpose I/O         P10           GPI0_18         IO         General-purpose I/O         N10           GPI0_19         IO         General-purpose I/O         E14           GPI0_20         IO         General-purpose I/O         E14           GPI0_21         IO         General-purpose I/O         G14           GPI0_22         IO         General-purpose I/O         R11           GPI0_23         IO         General-purpose I/O         N13           GPI0_25         IO         General-purpose I/O         N13           GPI0_25         IO         General-purpose I/O         N13           GPI0_26         IO         General-purpose I/O         N13           GPI0_27         IO         General-purpose I/O         K13           GPI0_28         IO         General-purpose I/O         P4           GPI0_29         IO         General-purpose I/O         G13           GPI0_29         IO         General-purpose I/O         G13           GPI0_30         IO         General-purpose I/O         G13           GPI0_31         IO         General-purpose I/O         R4           GPI0_31         IO         General-purpose I/O
GPI0_18         IO         General-purpose I/O         N10           GPI0_19         IO         General-purpose I/O         D13           GPI0_20         IO         General-purpose I/O         E14           GPI0_21         IO         General-purpose I/O         F13           GPI0_22         IO         General-purpose I/O         G14           GPI0_23         IO         General-purpose I/O         R11           GPI0_25         IO         General-purpose I/O         N13           GPI0_26         IO         General-purpose I/O         N13           GPI0_25         IO         General-purpose I/O         K13           GPI0_26         IO         General-purpose I/O         K13           GPI0_27         IO         General-purpose I/O         K13           GPI0_28         IO         General-purpose I/O         G13           GPI0_29         IO         General-purpose I/O         G13           GPI0_30         IO         General-purpose I/O         C13           GPI0_31         IO         General-purpose I/O         R4           GPI0_32         IO         General-purpose I/O         P5           GPI0_33         IO         General-purpose I/O
GPI0_18         IO         General-purpose I/O         N10           GPI0_19         IO         General-purpose I/O         D13           GPI0_20         IO         General-purpose I/O         E14           GPI0_21         IO         General-purpose I/O         F13           GPI0_22         IO         General-purpose I/O         G14           GPI0_23         IO         General-purpose I/O         R11           GPI0_24         IO         General-purpose I/O         N13           GPI0_25         IO         General-purpose I/O         N13           GPI0_26         IO         General-purpose I/O         K13           GPI0_27         IO         General-purpose I/O         K13           GPI0_28         IO         General-purpose I/O         K13           GPI0_28         IO         General-purpose I/O         G13           GPI0_29         IO         General-purpose I/O         G13           GPI0_29         IO         General-purpose I/O         C13           GPI0_30         IO         General-purpose I/O         R4           GPI0_31         IO         General-purpose I/O         P5           GPI0_33         IO         General-purpose I/O
GPI0_19         IO         General-purpose I/O         D13           GPI0_20         IO         General-purpose I/O         E14           GPI0_21         IO         General-purpose I/O         F13           GPI0_22         IO         General-purpose I/O         G14           GPI0_23         IO         General-purpose I/O         R11           GPI0_24         IO         General-purpose I/O         N13           GPI0_25         IO         General-purpose I/O         N13           GPI0_26         IO         General-purpose I/O         N13           GPI0_26         IO         General-purpose I/O         N8           GPI0_26         IO         General-purpose I/O         K13           GPI0_27         IO         General-purpose I/O         P9           GPI0_28         IO         General-purpose I/O         P4           GPI0_29         IO         General-purpose I/O         C13           GPI0_30         IO         General-purpose I/O         R4           GPI0_31         IO         General-purpose I/O         P5           GPI0_33         IO         General-purpose I/O         R5           GPI0_34         IO         General-purpose I/O
GPI0_20         IO         General-purpose I/O         E14           GPI0_21         IO         General-purpose I/O         F13           GPI0_22         IO         General-purpose I/O         G14           GPI0_23         IO         General-purpose I/O         R11           GPI0_24         IO         General-purpose I/O         N13           GPI0_25         IO         General-purpose I/O         N13           GPI0_26         IO         General-purpose I/O         K13           GPI0_26         IO         General-purpose I/O         K13           GPI0_27         IO         General-purpose I/O         P9           GPI0_27         IO         General-purpose I/O         P4           GPI0_28         IO         General-purpose I/O         G13           GPI0_30         IO         General-purpose I/O         C13           GPI0_31         IO         General-purpose I/O         R4           GPI0_32         IO         General-purpose I/O         P5           GPI0_33         IO         General-purpose I/O         R5           GPI0_34         IO         General-purpose I/O         P6           GPI0_35         IO         General-purpose I/O
GPI0_21         IO         General-purpose I/O         F13           GPI0_22         IO         General-purpose I/O         G14           GPI0_23         IO         General-purpose I/O         R11           GPI0_24         IO         General-purpose I/O         N13           GPI0_25         IO         General-purpose I/O         N13           GPI0_26         IO         General-purpose I/O         K13           GPI0_27         IO         General-purpose I/O         K13           GPI0_27         IO         General-purpose I/O         K13           GPI0_27         IO         General-purpose I/O         P4           GPI0_28         IO         General-purpose I/O         G13           GPI0_29         IO         General-purpose I/O         G13           GPI0_30         IO         General-purpose I/O         C13           GPI0_31         IO         General-purpose I/O         R4           GPI0_32         IO         General-purpose I/O         R5           GPI0_33         IO         General-purpose I/O         R5           GPI0_34         IO         General-purpose I/O         R5           GPI0_35         IO         General-purpose I/O
GPI0_22         IO         General-purpose I/O         G14           GPI0_23         IO         General-purpose I/O         R11           GPI0_24         IO         General-purpose I/O         N13           GPI0_25         IO         General-purpose I/O         N13           GPI0_26         IO         General-purpose I/O         N8           GPI0_26         IO         General-purpose I/O         K13           GPI0_27         IO         General-purpose I/O         P9           GPI0_28         IO         General-purpose I/O         P4           GPI0_28         IO         General-purpose I/O         G13           GPI0_29         IO         General-purpose I/O         G13           GPI0_30         IO         General-purpose I/O         C13           GPI0_31         IO         General-purpose I/O         R4           GPI0_32         IO         General-purpose I/O         R5           GPI0_33         IO         General-purpose I/O         R5           GPI0_34         IO         General-purpose I/O         R7           GPI0_35         IO         General-purpose I/O         R7           GPI0_36         IO         General-purpose I/O         <
GPIO_23         IO         General-purpose I/O         R11           GPIO_24         IO         General-purpose I/O         N13           GPIO_25         IO         General-purpose I/O         N8           GPIO_26         IO         General-purpose I/O         K13           GPIO_26         IO         General-purpose I/O         K13           GPIO_27         IO         General-purpose I/O         P9           GPIO_28         IO         General-purpose I/O         G13           GPIO_29         IO         General-purpose I/O         C13           GPIO_30         IO         General-purpose I/O         C13           GPIO_31         IO         General-purpose I/O         R4           GPIO_32         IO         General-purpose I/O         R4           GPIO_32         IO         General-purpose I/O         R5           GPIO_33         IO         General-purpose I/O         R5           GPIO_34         IO         General-purpose I/O         R7           GPIO_35         IO         General-purpose I/O         R7           GPIO_36         IO         General-purpose I/O         R7           GPIO_36         IO         General-purpose I/O <t< td=""></t<>
GPI0_24         IO         General-purpose I/O         N13           GPI0_25         IO         General-purpose I/O         N8           GPI0_26         IO         General-purpose I/O         K13           GPI0_27         IO         General-purpose I/O         P9           GPI0_28         IO         General-purpose I/O         P4           GPI0_29         IO         General-purpose I/O         G13           GPI0_30         IO         General-purpose I/O         C13           GPI0_31         IO         General-purpose I/O         R4           GPI0_32         IO         General-purpose I/O         R4           GPI0_31         IO         General-purpose I/O         R5           GPI0_33         IO         General-purpose I/O         R5           GPI0_34         IO         General-purpose I/O         R7           GPI0_35         IO         General-purpose I/O         R7           GPI0_36         IO         General-purpose I/O         R7           GPI0_37         IO         General-purpose I/O         R7           GPI0_38         IO         General-purpose I/O         P7           GPI0_38         IO         General-purpose I/O         R
GPIO_25         IO         General-purpose I/O         N8           GPIO_26         IO         General-purpose I/O         K13           GPIO_27         IO         General-purpose I/O         P9           GPIO_28         IO         General-purpose I/O         P4           GPIO_29         IO         General-purpose I/O         G13           GPIO_30         IO         General-purpose I/O         C13           GPIO_31         IO         General-purpose I/O         R4           GPIO_32         IO         General-purpose I/O         R4           GPIO_32         IO         General-purpose I/O         R4           GPIO_33         IO         General-purpose I/O         R5           GPIO_33         IO         General-purpose I/O         R5           GPIO_34         IO         General-purpose I/O         P6           GPIO_35         IO         General-purpose I/O         P7           GPIO_36         IO         General-purpose I/O         P7           GPIO_38         IO         General-purpose I/O         P7           GPIO_38         IO         General-purpose I/O         P8
GPI0_26         IO         General-purpose I/O         K13           GPI0_27         IO         General-purpose I/O         P9           GPI0_28         IO         General-purpose I/O         P4           GPI0_29         IO         General-purpose I/O         G13           GPI0_30         IO         General-purpose I/O         C13           GPI0_31         IO         General-purpose I/O         R4           GPI0_32         IO         General-purpose I/O         R4           GPI0_32         IO         General-purpose I/O         R5           GPI0_33         IO         General-purpose I/O         R5           GPI0_34         IO         General-purpose I/O         P6           GPI0_35         IO         General-purpose I/O         P7           GPI0_36         IO         General-purpose I/O         R7           GPI0_36         IO         General-purpose I/O         P7           GPI0_38         IO         General-purpose I/O         R8           GPI0_38         IO         General-purpose I/O         P8
GPIO_27         IO         General-purpose I/O         P9           GPIO_28         IO         General-purpose I/O         P4           GPIO_29         IO         General-purpose I/O         G13           GPIO_30         IO         General-purpose I/O         C13           GPIO_31         IO         General-purpose I/O         R4           GPIO_32         IO         General-purpose I/O         R4           GPIO_32         IO         General-purpose I/O         R5           GPIO_33         IO         General-purpose I/O         R5           GPIO_34         IO         General-purpose I/O         R7           GPIO_35         IO         General-purpose I/O         R7           GPIO_36         IO         General-purpose I/O         R7           GPIO_37         IO         General-purpose I/O         P7           GPIO_38         IO         General-purpose I/O         P8
GPIO_28         IO         General-purpose I/O         P4           GPIO_29         IO         General-purpose I/O         G13           GPIO_30         IO         General-purpose I/O         C13           GPIO_31         IO         General-purpose I/O         R4           GPIO_32         IO         General-purpose I/O         R5           GPIO_33         IO         General-purpose I/O         R5           GPIO_34         IO         General-purpose I/O         R5           GPIO_35         IO         General-purpose I/O         R7           GPIO_36         IO         General-purpose I/O         R7           GPIO_37         IO         General-purpose I/O         R8           GPIO_38         IO         General-purpose I/O         P7           GPIO_38         IO         General-purpose I/O         P8
GPIO_29         IO         General-purpose I/O         G13           GPIO_30         IO         General-purpose I/O         C13           GPIO_31         IO         General-purpose I/O         R4           GPIO_32         IO         General-purpose I/O         P5           GPIO_33         IO         General-purpose I/O         R5           GPIO_34         IO         General-purpose I/O         R5           GPIO_35         IO         General-purpose I/O         P6           GPIO_36         IO         General-purpose I/O         P7           GPIO_37         IO         General-purpose I/O         P7           GPIO_37         IO         General-purpose I/O         P8
GPIO_30         IO         General-purpose I/O         C13           GPIO_31         IO         General-purpose I/O         R4           GPIO_32         IO         General-purpose I/O         P5           GPIO_33         IO         General-purpose I/O         R5           GPIO_34         IO         General-purpose I/O         R5           GPIO_34         IO         General-purpose I/O         P6           GPIO_35         IO         General-purpose I/O         P7           GPIO_36         IO         General-purpose I/O         P7           GPIO_37         IO         General-purpose I/O         P8           GPIO_38         IO         General-purpose I/O         P8
GPIO_32         IO         General-purpose I/O         P5           GPIO_33         IO         General-purpose I/O         R5           GPIO_34         IO         General-purpose I/O         P6           GPIO_35         IO         General-purpose I/O         R7           GPIO_36         IO         General-purpose I/O         P7           GPIO_37         IO         General-purpose I/O         R8           GPIO_38         IO         General-purpose I/O         P8
GPIO_32         IO         General-purpose I/O         P5           GPIO_33         IO         General-purpose I/O         R5           GPIO_34         IO         General-purpose I/O         P6           GPIO_35         IO         General-purpose I/O         R7           GPIO_36         IO         General-purpose I/O         P7           GPIO_37         IO         General-purpose I/O         R8           GPIO_38         IO         General-purpose I/O         P8
GPIO_34         IO         General-purpose I/O         P6           GPIO_35         IO         General-purpose I/O         R7           GPIO_36         IO         General-purpose I/O         P7           GPIO_37         IO         General-purpose I/O         R8           GPIO_38         IO         General-purpose I/O         P8
GPIO_35         IO         General-purpose I/O         R7           GPIO_36         IO         General-purpose I/O         P7           GPIO_37         IO         General-purpose I/O         R8           GPIO_38         IO         General-purpose I/O         P8
GPIO_36         IO         General-purpose I/O         P7           GPIO_37         IO         General-purpose I/O         R8           GPIO_38         IO         General-purpose I/O         P8
GPIO_37         IO         General-purpose I/O         R8           GPIO_38         IO         General-purpose I/O         P8
GPIO_38 IO General-purpose I/O P8
GPIO_47 IO General-purpose I/O N15
I2C_SCL IO I2C Clock G14, N4
I2C_SDA IO I2C Data F13, N5
LVDS_TXP[0] O J14
LVDS_TXM[0]     O
LVDS_TXP[1] O Differential data Out Lang 1 K14
LVDS_TXM[1]     Differential data Out – Lane 1
LVDS_CLKP 0 Differential clock Out
Differential clock Out       LVDS_CLKM     O
LVDS_FRCLKP O Differential Frame Cleak M14
Differential Frame Clock         M15
MCU_CLKOUT O Programmable clock given out to external MCU or the processor N8
MSS_UARTA_RX I Master Subsystem - UART A Receive F14, N4, R11

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SIGNAL NAME	PIN TYPE	DESCRIPTION	BALL NO.
MSS_UARTA_TX	0	Master Subsystem - UART A Transmit	H14, N13, N5, R4
MSS_UARTB_RX	IO	Master Subsystem - UART B Receive	N4, P4
MSS_UARTB_TX	0	Master Subsystem - UART B Transmit	F14, H14, K13, N13, N5, P10, P7
NDMM_EN	I	Debug Interface (Hardware In Loop) Enable - Active Low Signal	N13, N5
NERROR_IN	I	Failsafe input to the device. Nerror output from any other device can be concentrated in the error signaling monitor module inside the device and appropriate action can be taken by Firmware	N7
NERROR_OUT	0	Open drain fail safe output signal. Connected to PMIC/ Processor/MCU to indicate that some severe criticality fault has happened. Recovery would be through reset.	N6
PMIC_CLKOUT	0	Output Clock from AWR6843 device for PMIC	H13, K13, P9
QSPI[0]	IO	QSPI Data Line #0 (Used with Serial Data Flash)	R13
QSPI[1]	I	QSPI Data Line #1 (Used with Serial Data Flash)	N12
QSPI[2]	I	QSPI Data Line #2 (Used with Serial Data Flash)	R14
QSPI[3]	I	QSPI Data Line #3 (Used with Serial Data Flash)	P12
QSPI_CLK	0	QSPI Clock (Used with Serial Data Flash)	R12
QSPI_CLK_EXT	I	QSPI Clock (Used with Serial Data Flash)	H14
QSPI_CS_N	0	QSPI Chip Select (Used with Serial Data Flash)	P11
RS232_RX	I	Debug UART (Operates as Bus Master) - Receive Signal	N4
RS232_TX	0	Debug UART (Operates as Bus Master) - Transmit Signal	N5
SOP[0]	I	Sense On Power - Line#0	N13
SOP[1]	I	Sense On Power - Line#1	G13
SOP[2]	I	Sense On Power - Line#2	P9
SPIA_CLK	10	SPI Channel A - Clock	E13
SPIA_CS_N	10	SPI Channel A - Chip Select	E15
SPIA_MISO	IO	SPI Channel A - Master In Slave Out	E14
SPIA_MOSI	IO	SPI Channel A - Master Out Slave In	D13
SPIB_CLK	IO	SPI Channel B - Clock	F14, R12
SPIB_CS_N	IO	SPI Channel B Chip Select (Instance ID 0)	H14, P11
SPIB_CS_N_1	IO	SPI Channel B Chip Select (Instance ID 1)	G13, J13, P13
SPIB_CS_N_2	IO	SPI Channel B Chip Select (Instance ID 2)	G13, J13, N12
SPIB_MISO	IO	SPI Channel B - Master In Slave Out	G14, R13
SPIB_MOSI	IO	SPI Channel B - Master Out Slave In	F13, N12
SPI_HOST_INTR	0	Out of Band Interrupt to an external host communicating over SPI	P13
SYNC_IN	I	Low frequency Synchronization signal input	P4
SYNC_OUT	0	Low Frequency Synchronization Signal output	G13, J13, K13, P4
тск	I	JTAG Test Clock	P10
TDI	I	JTAG Test Data Input	R11
TDO	0	JTAG Test Data Output	N13
TMS	I	JTAG Test Mode Signal	N10
TRACE_CLK	0	Debug Trace Output - Clock	N15
TRACE_CTL	0	Debug Trace Output - Control	N14
TRACE_DATA_0	0	Debug Trace Output - Data Line	R4
TRACE_DATA_1	0	Debug Trace Output - Data Line	P5
TRACE_DATA_2	0	Debug Trace Output - Data Line	R5
TRACE_DATA_3	0	Debug Trace Output - Data Line	P6
TRACE_DATA_4	0	Debug Trace Output - Data Line	R7



SIGNAL NAME	PIN TYPE	DESCRIPTION	BALL NO.
TRACE_DATA_5	0	Debug Trace Output - Data Line	P7
TRACE_DATA_6	0	Debug Trace Output - Data Line	R8
TRACE_DATA_7	0	Debug Trace Output - Data Line	P8
FRAME_START	0	Pulse signal indicating the start of each frame	N8, K13, P9
CHIRP_START	0	Pulse signal indicating the start of each chirp	N8, K13, P9
CHIRP_END	0	Pulse signal indicating the end of each chirp	N8, K13, P9
ADC_VALID	0	When high, indicating valid ADC samples	P13, H13
WARM_RESET	Ю	Open drain fail safe warm reset signal. Can be driven from PMIC for diagnostic or can be used as status signal that the device is going through reset.	N9

## 6.3.2 Signal Descriptions - Analog

INTERFACE	SIGNAL NAME	PIN TYPE	DESCRIPTION	BALL NO.
	TX1	0	Single ended transmitter1 o/p	B4
Transmitters	TX2	0	Single ended transmitter2 o/p	B6
	ТХ3	0	Single ended transmitter3 o/p	B8
	RX1	1	Single ended receiver1 i/p	M2
Dessivers	RX2	I	Single ended receiver2 i/p	K2
Receivers	RX3	I	Single ended receiver3 i/p	H2
	RX4	I	Single ended receiver4 i/p	F2
Reset	NRESET	1	Power on reset for chip. Active low	R3
Reference Oscillator	CLKP	I	In XTAL mode: Differential port for reference crystal In External clock mode: Single ended input reference clock port	B15
Oscillator	CLKM	I	In XTAL mode: Differential port for reference crystal In External clock mode: Connect this port to ground	C15
Reference clock	OSC_CLKOUT	0	Reference clock output from clocking subsystem after cleanup PLL (1.4V output voltage swing).	A14
Bandgap voltage	VBGAP	0	Device's Band Gap Reference Output	B10
	VDDIN	Power	1.2V digital power supply	H15, N11, P15, R6
	VIN_SRAM	Power	1.2V power rail for internal SRAM	G15
	VNWA	Power	1.2V power rail for SRAM array back bias	P14
Power supply	VIOIN	Power	I/O Supply (3.3V or 1.8V): All CMOS I/Os would operate on this supply	R10, F15
	VIOIN_18	Power	1.8V supply for CMOS IO	R9
	VIN_18CLK	Power	1.8V supply for clock module	B11
	VIOIN_18DIFF	Power	1.8V supply for LVDS port	D15
	VPP	Power	Voltage supply for fuse chain	L13
	VIN_13RF1	Power	1.3V Analog and RF supply,VIN_13RF1 and VIN_13RF2 could be shorted on the board	G5, H5, J5
Power supply	VIN_13RF2	Power	1.3V Analog and RF supply	C2,D2
	VIN_18BB	Power	1.8V Analog base band power supply	K5, F5
	VIN_18VCO	Power	1.8V RF VCO supply	B12

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INTERFACE	SIGNAL NAME	PIN TYPE	DESCRIPTION	BALL NO.
	VSS	Ground	Digital ground	L5, L6, L8, L10, K7, K8, K9, K10, K11, J6, J7, J8, J10, H7, H9, H11, G6, G7, G8, G10, F9, F11, E5, E6, E8, E10, E11, R15
	VSSA	Ground	Analog ground	A1, A3, A5, A7, A9, A13, A15, B1, B3, B5, B7, B9, B14, C1, C3, C4, C5, C6, C7, C8, C9, C14, E1, E2, E3, F3, G1, G2, G3, H3, J1, J2, J3, K3, L1, L2, L3, M3, N1, N2, N3, R1
	VOUT_14APLL	0	Internal LDO output	A10
Internal LDO output/ inputs	VOUT_14SYNTH	0	Internal LDO output	B13
	VOUT_PA	10	Internal LDO output	A2, B2
Test and Debug	Analog Test1 / GPADC1	10	Analog IO dedicated for ADC service	P1
output for pre-	Analog Test2 / GPADC2	10	Analog IO dedicated for ADC service	P2
production phase. Can be pinned out	Analog Test3 / GPADC3	Ю	Analog IO dedicated for ADC service	P3
on production	Analog Test4 / GPADC4	10	Analog IO dedicated for ADC service	R2
hardware for field	ANAMUX / GPADC5	10	Analog IO dedicated for ADC service	C13
debug	VSENSE / GPADC6	Ю	Analog IO dedicated for ADC service	D14



## **7** Specifications

### 7.1 Absolute Maximum Ratings

	PARAMETERS <sup>(1)</sup> <sup>(2)</sup>	MIN	MAX	UNIT
VDDIN	1.2 V digital power supply	-0.5	1.4	V
VIN_SRAM	1.2 V power rail for internal SRAM	-0.5	1.4	V
VNWA	1.2 V power rail for SRAM array back bias	-0.5	1.4	V
VIOIN	I/O supply (3.3 V or 1.8 V): All CMOS I/Os would operate on this supply.	-0.5	3.8	V
VIOIN_18	1.8 V supply for CMOS IO	-0.5	2	V
VIN_18CLK	1.8 V supply for clock module	-0.5	2	V
VIOIN_18DIFF	1.8 V supply for LVDS port	-0.5	2	V
VIN_13RF1	1.3 V Analog and RF supply, VIN_13RF1 and VIN_13RF2 could	-0.5	1.45	V
VIN_13RF2	be shorted on the board.	-0.5	1.45	v
VIN_13RF1 (1-V Internal LDO bypass mode) VIN_13RF2 (1-V Internal LDO	Device supports mode where external Power Management block can supply 1 V on VIN_13RF1 and VIN_13RF2 rails. In this configuration, the internal LDO of the device would be kept bypassed.	-0.5	1.4	V
bypass mode)				
VIN_18BB	1.8-V Analog baseband power supply	-0.5	2	V
VIN_18VCO supply	1.8-V RF VCO supply	-0.5	2	V
Input and output	Dual-voltage LVCMOS inputs, 3.3 V or 1.8 V (Steady State)	-0.3V	VIOIN + 0.3	
voltage range	Dual-voltage LVCMOS inputs, operated at 3.3 V/1.8 V (Transient Overshoot/Undershoot) or external oscillator input	VIOIN + 20% up to 20% of signal period		V
CLKP, CLKM	Input ports for reference crystal	-0.5	2	V
Clamp current	Input or Output Voltages 0.3 V above or below their respective power rails. Limit clamp current that flows through the internal diode protection cells of the I/O.	-20	20	mA
TJ	Operating junction temperature range	-40	125	°C
T <sub>STG</sub>	Storage temperature range after soldered onto PC board	-55	150	°C

(1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) All voltage values are with respect to  $V_{SS},$  unless otherwise noted.

#### 7.2 ESD Ratings

			VALUE	UNIT
V	Electrostatic discharge	Human-body model (HBM), per AEC Q100-002 <sup>(1)</sup>	±2000	V
V <sub>(ESD)</sub>	Electrostatic discharge	Charged-device model (CDM), per AEC Q100-011 <sup>(2)</sup>	±500	v

(1) AEC Q100-002 indicates that HBM stressing shall be in accordance with the ANSI/ESDA/JEDEC JS-001 specification.

(2) Corner pins are rated as ±750 V



## 7.3 Power-On Hours (POH)

JUNCTION TEMPERATURE $(T_j)^{(1)}^{(2)}$	OPERATING CONDITION	NOMINAL CVDD VOLTAGE (V)	POWER-ON HOURS [POH] (HOURS)
-40°C			600 (6%)
75°C	1000/	1.2	2000 (20%)
95°C	100% duty cycle	1.2	6500 (65%)
125°C			900 (9%)

(1) This information is provided solely for your convenience and does not extend or modify the warranty provided under TI's standard terms and conditions for TI semiconductor products.

(2) The specified POH are applicable with max Tx output power settings using the default firmware gain tables. The specified POH would not be applicable, if the Tx gain table is overwritten using an API.



#### 7.4 Recommended Operating Conditions

		MIN	NOM	MAX	UNIT		
VDDIN	1.2 V digital power supply	1.14	1.2	1.32	V		
VIN_SRAM	1.2 V power rail for internal SRAM	1.14	1.2	1.32	V		
VNWA	1.2 V power rail for SRAM array back bias	1.14	1.2	1.32	V		
VIOIN	I/O supply (3.3 V or 1.8 V): All CMOS I/Os would operate on this supply.	3.15 1.71	3.3 1.8	3.45 1.89	V		
VIOIN_18	1.8 V supply for CMOS IO	1.71	1.8	1.09	V		
VIN_18CLK	1.8 V supply for clock module	1.71	1.8	1.9	V		
VIOIN_18DIFF	1.8 V supply for LVDS port	1.71	1.8	1.9	V		
VIN_13RF1	1.3 V Analog and RF supply. VIN_13RF1 and VIN_13RF2 could be shorted on the board	1.23	1.3	1.36	V		
VIN_13RF2							
VIN_13RF1 (1-V Internal LDO bypass mode)	Device supports mode where external Power Management block can supply 1 V on VIN_13RF1 and VIN_13RF2 rails. In	0.95	1	1.05	V		
VIN_13RF2 (1-V Internal LDO bypass mode)	this configuration, the internal LDO of the device would be kept bypassed.	0.00	·		·		
VIN18BB	1.8-V Analog baseband power supply	1.71	1.8	1.9	V		
VIN_18VCO	1.8V RF VCO supply	1.71	1.8	1.9	V		
N	Voltage Input High (1.8 V mode)	1.17			V		
V <sub>IH</sub>	Voltage Input High (3.3 V mode)	2.25			v		
N	Voltage Input Low (1.8 V mode)			0.3*VIOIN	V		
VIL	Voltage Input Low (3.3 V mode)			0.62	v		
V <sub>OH</sub>	High-level output threshold (I <sub>OH</sub> = 6 mA)	VIOIN – 450			mV		
V <sub>OL</sub>	Low-level output threshold (I <sub>OL</sub> = 6 mA)			450	mV		
	V <sub>IL</sub> (1.8V Mode)			0.45			
NRESET	V <sub>IH</sub> (1.8V Mode)	0.96			V		
SOP[2:0]	V <sub>IL</sub> (3.3V Mode)			0.65	5 V		
	V <sub>IH</sub> (3.3V Mode)	1.57					

#### 7.5 Power Supply Specifications

Table 7-1 describes the four rails from an external power supply block of the AWR6843 device.

 Table 7-1. Power Supply Rails Characteristics

SUPPLY	DEVICE BLOCKS POWERED FROM THE SUPPLY	RELEVANT IOS IN THE DEVICE
1.8 V	Synthesizer and APLL VCOs, crystal oscillator, IF Amplifier stages, ADC, LVDS	Input: VIN_18VCO, VIN18CLK, VIN_18BB, VIOIN_18DIFF, VIOIN_18 LDO Output: VOUT_14SYNTH, VOUT_14APLL
1.3 V (or 1 V in internal LDO bypass mode) <sup>(1)</sup>	Power Amplifier, Low Noise Amplifier, Mixers and LO Distribution	Input: VIN_13RF2, VIN_13RF1 LDO Output: VOUT_PA
3.3 V (or 1.8 V for 1.8 V I/O mode)	Digital I/Os	Input VIOIN
1.2 V	Core Digital and SRAMs	Input: VDDIN, VIN_SRAM

(1) Three simultaneous transmitter operation is supported only in 1-V LDO bypass and PA LDO disable mode. In this mode 1V supply needs to be fed on the VOUT PA pin.

The 1.3-V (1.0 V) and 1.8-V power supply ripple specifications mentioned in Table 7-2 are defined to meet a target spur level of -105 dBc (RF Pin = -15 dBm) at the RX. The spur and ripple levels have a dB-to-dB relationship, for example, a 1-dB increase in supply ripple leads to a ~1 dB increase in spur level. Values quoted are rms levels for a sinusoidal input applied at the specified frequency.

	RF RAIL		VCO/IF RAIL
FREQUENCY (kHz)	1.0 V (INTERNAL LDO BYPASS) (μV <sub>RMS</sub> )	1.3 V (μV <sub>RMS</sub> )	1.8 V (μV <sub>RMS</sub> )
137.5	7	648	83
275	5	76	21
550	3	22	11
1100	2	4	6
2200	11	82	13
4400	13	93	19
6600	22	117	29

## Table 7.2 Dinnla Creations

#### 7.6 Power Consumption Summary

Table 7-3 and Table 7-4 summarize the power consumption at the power terminals.

#### Table 7-3. Maximum Current Ratings at Power Terminals

PARAMETER	SUPPLY NAME	DESCRIPTION	MIN	TYP	MAX	UNIT
Current consumption <sup>(1)</sup>	VDDIN, VIN_SRAM, VNWA	Total current drawn by all nodes driven by 1.2V rail			1000	
	VIN_13RF1, VIN_13RF2	Total current drawn by all nodes driven by 1.3V or 1.0V rail (2TX, 4 RX simultaneously) <sup>(3)</sup>		2000		
	VIOIN_18, VIN_18CLK, VIOIN_18DIFF, VIN_18BB, VIN_18VCO	Total current drawn by all nodes driven by 1.8V rail	850		mA	
	VIOIN	Total current drawn by all nodes driven by 3.3V rail <sup>(2)</sup>		50		

(1) The specified current values are at typical supply voltage level.

(2) The exact VIOIN current depends on the peripherals used and their frequency of operation.

Simultaneous 3 Transmitter operation is supported only with 1-V LDO bypass and PA LDO disable mode. In this mode, the 1-V supply (3) needs to be fed on the VOUT PA pin. In this case, the peak 1-V supply current goes up to 2500 mA. To enable the LDO bypass mode, see the Interface Control document in the mmWave software development kit (SDK).

#### Table 7-4. Average Power Consumption at Power Terminals

PARAMETER	CONDITION		DESCRIPTION	MIN	TYP	MAX	UNIT	
			1TX, 4RX	Regular power ADC mode 6.4		1.19		
Average power 1.0-V internal		24% duty cycle	2TX, 4RX <sup>(1)</sup>	Msps complex transceiver, 13.13-ms frame, 64 chirps, 256 samples/chirp, 8.5-µs interchirp time, DSP + Hardware accelerator active		1.25		W
consumption <sup>(1)</sup>	consumption <sup>(1)</sup> LDO bypass mode		1TX, 4RX	Regular power ADC mode 6.4		1.62		vv
		48% duty cycle	2TX, 4RX <sup>(1)</sup>	Msps complex transceiver, 13.13-ms frame, 64 chirps, 256 samples/chirp, 8.5-µs interchirp time, DSP + Hardware accelerator active		1.75		

(1) Two TX antennas are on simultaneously.



## 7.7 RF Specification

over recommended operating conditions (unless otherwise noted)

	PARAMETER			TYP	MAX	UNIT
	Noise figure	60 to 64 GHz		12		dB
	1-dB compression point (Out Of Band )	1)		-12		dBm
	Maximum gain			48		dB
	Gain range			18		dB
Dessiver	Gain step size			2		dB
Receiver	IF bandwidth <sup>(2)</sup>			10	MHz	
	A2D sampling rate (real)				25	Msps
	A2D sampling rate (complex 1x)				12.5	Msps
	A2D resolution			12		Bits
	Idle Channel Spurs			-90		dBFS
Transmitter	Output power			12		dBm
Transmiller	Power backoff range			26		dB
	Frequency range		60		64	GHz
Clock subsystem	Ramp rate				250	MHz/µs
	Phase noise at 1-MHz offset	60 to 64 GHz		-93		dBc/Hz

(1) 1-dB Compression Point (Out Of Band) is measured by feed a Continuous wave Tone (10 kHz) well below the lowest HPF cut-off frequency.

(2) The analog IF stages include high-pass filtering, with two independently configurable first-order high-pass corner frequencies. The set of available HPF corners is summarized as follows:

Available HPF Corner Frequencies (kHz)

HPF1 HPF2

175, 235, 350, 700

350, 700, 1400, 2800

The filtering performed by the digital baseband chain is targeted to provide:

- Less than ±0.5 dB pass-band ripple/droop, and
- Better than 60 dB anti-aliasing attenuation for any frequency that can alias back into the pass-band.

#### 7.8 CPU Specifications

over recommended operating conditions (unless otherwise noted)

	PARAMETER	MIN	TYP	MAX	UNIT
DSP	Clock Speed		600		MHz
Subsystem	L1 Code Memory		32		KB
(C674 Family)	L1 Data Memory		32		KB
ranny)	L2 Memory		256		KB
Master	Clock Speed		200		MHz
Controller Subsystem	Tightly Coupled Memory - A (Program)		512		KB
(R4F Family)	Tightly Coupled Memory - B (Data)		192		KB
Shared Memory	Shared L3 Memory		768		KB



## 7.9 Thermal Resistance Characteristics for FCBGA Package [ABL0161]

THERMAL N	°C/W <sup>(2)</sup> (3)	
RO <sub>JC</sub>	Junction-to-case	4.92
RO <sub>JB</sub>	Junction-to-board	6.57
RO <sub>JA</sub>	Junction-to-free air	22.3
RO <sub>JMA</sub>	Junction-to-moving air	N/A <sup>(4)</sup>
Psi <sub>JT</sub>	Junction-to-package top	4.92
Psi <sub>JB</sub>	Junction-to-board	6.4

(1) For more information about traditional and new thermal metrics, see Semiconductor and IC Package Thermal Metrics.

(2) °C/W = degrees Celsius per watt.

(3) These values are based on a JEDEC-defined 2S2P system (with the exception of the Theta JC [RO<sub>JC</sub>] value, which is based on a JEDEC-defined 1S0P system) and will change based on environment as well as application. For more information, see these EIA/ JEDEC standards:

• JESD51-2, Integrated Circuits Thermal Test Method Environmental Conditions - Natural Convection (Still Air)

• JESD51-3, Low Effective Thermal Conductivity Test Board for Leaded Surface Mount Packages

• JESD51-7, High Effective Thermal Conductivity Test Board for Leaded Surface Mount Packages

• JESD51-9, Test Boards for Area Array Surface Mount Package Thermal Measurements

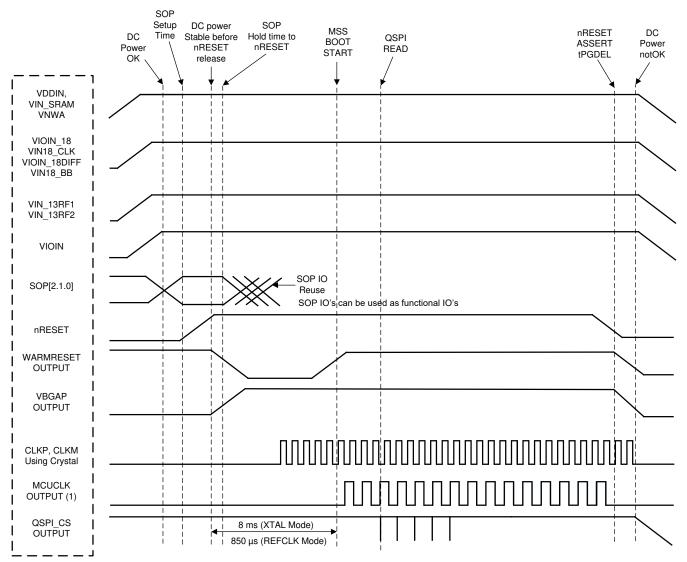
(4) N/A = not applicable



#### 7.10 Timing and Switching Characteristics

#### 7.10.1 Power Supply Sequencing and Reset Timing

The AWR6843 device expects all external voltage rails to be stable before reset is deasserted. Figure 7-1 describes the device wake-up sequence.



A. MCU\_CLK\_OUT in autonomous mode, where AWR6843 application is booted from the serial flash, MCU\_CLK\_OUT is not enabled by default by the device bootloader.

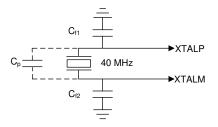
#### Figure 7-1. Device Wake-up Sequence



#### 7.10.2 Input Clocks and Oscillators

#### 7.10.2.1 Clock Specifications

The AWR6843 requires external clock source (that is, a 40-MHz crystal or external oscillator to CLKP) for initial boot and as a reference for an internal APLL hosted in the device. An external crystal is connected to the device pins. Figure 7-2 shows the crystal implementation.



#### Figure 7-2. Crystal Implementation

#### Note

The load capacitors,  $C_{f1}$  and  $C_{f2}$  in Figure 7-2, should be chosen such that Equation 1 is satisfied.  $C_L$  in the equation is the load specified by the crystal manufacturer. All discrete components used to implement the oscillator circuit should be placed as close as possible to the associated oscillator CLKP and CLKM pins.

$$C_{L} = C_{f1} \times \frac{C_{f2}}{C_{f1} + C_{f2}} + C_{P}$$

(1)

Table 7-5 lists the electrical characteristics of the clock crystal.

Table 7-5. Cry	stal Electrical Characteristics (	Oscillator Mode)	
----------------	-----------------------------------	------------------	--

NAME	DESCRIPTION	MIN	ТҮР	MAX	UNIT
f <sub>P</sub>	Parallel resonance crystal frequency		40		MHz
CL	Crystal load capacitance	5	8	12	pF
ESR	Crystal ESR			50	Ω
Temperature range	Expected temperature range of operation	-40		105	°C
Frequency tolerance	Crystal frequency tolerance <sup>(1) (2) (3)</sup>	-50		50	ppm
Drive level			50	200	μW

(1) The crystal manufacturer's specification must satisfy this requirement.

(2) Includes initial tolerance of the crystal, drift over temperature, aging and frequency pulling due to incorrect load capacitance.

(3) Crystal tolerance affects radar sensor accuracy.

In the case where an external clock is used as the clock resource, the signal is fed to the CLKP pin only; CLKM is grounded. The phase noise requirement is very important when a 40-MHz clock is fed externally. Table 7-6 lists the electrical characteristics of the external clock signal.



DADAM	DADAMETED		SPECIFICATION			
PARAMETER		MIN	ТҮР	MAX	UNIT	
	Frequency		40		MHz	
	AC-Amplitude	700		1200	mV (pp)	
	DC-V <sub>il</sub>	0.00		0.20	V	
	DC-V <sub>ih</sub>	1.6		1.95	V	
Input Clock:	Phase Noise at 1 kHz			-132	dBc/Hz	
External AC-coupled sine wave or DC- coupled square wave Phase Noise referred to 40 MHz	Phase Noise at 10 kHz			-143	dBc/Hz	
	Phase Noise at 100 kHz			-152	dBc/Hz	
	Phase Noise at 1 MHz			-153	dBc/Hz	
	Duty Cycle	35		65	%	
	Freq Tolerance	-50		50	ppm	
	Freq Tolerance	-50		50	ppm	

#### Table 7-6. External Clock Mode Specifications



#### 7.10.3 Multibuffered / Standard Serial Peripheral Interface (MibSPI)

#### 7.10.3.1 Peripheral Description

The MibSPI/SPI is a high-speed synchronous serial input/output port that allows a serial bit stream of programmed length (2 to 16 bits) to be shifted into and out of the device at a programmed bit-transfer rate. The MibSPI/SPI is normally used for communication between the microcontroller and external peripherals or another microcontroller.

Standard and MibSPI modules have the following features:

- 16-bit shift register
- Receive buffer register
- 8-bit baud clock generator
- SPICLK can be internally-generated (master mode) or received from an external clock source (slave mode)
- · Each word transferred can have a unique format.
- SPI I/Os not used in the communication can be used as digital input/output signals

#### 7.10.3.2 MibSPI Transmit and Receive RAM Organization

The Multibuffer RAM is comprised of 256 buffers. Each entry in the Multibuffer RAM consists of 4 parts: a 16-bit transmit field, a 16-bit receive field, a 16-bit control field and a 16-bit status field. The Multibuffer RAM can be partitioned into multiple transfer group with variable number of buffers each.

Section 7.10.3.2.2 and Section 7.10.3.2.3 assume the operating conditions stated in Section 7.10.3.2.1.

#### 7.10.3.2.1 SPI Timing Conditions

		MIN	TYP MAX	UNIT		
Input Condi	tions					
t <sub>R</sub>	Input rise time	1	3	ns		
t <sub>F</sub>	Input fall time	1	3	ns		
Output Con	ditions	•				
C <sub>LOAD</sub>	Output load capacitance	2	15	pF		

# 7.10.3.2.2 SPI Master Mode Switching Parameters (CLOCK PHASE = 0, SPICLK = output, SPISIMO = output, and SPISOMI = input)

NO. <sup>(1)</sup> (2) (3)		PARAMETER	MIN	TYP MAX	UNIT		
1	t <sub>c(SPC)M</sub>	Cycle time, SPICLK <sup>(4)</sup>		25	256 <sub>tc(VCLK)</sub>	ns	
2 <sup>(4)</sup> t <sub>w(SPCH</sub>	t <sub>w(SPCH)M</sub>	Pulse duration, SPICLK high (clock	0.5t <sub>c(SPC)M</sub> - 4	0.5t <sub>c(SPC)M</sub> + 4			
2(.)	t <sub>w(SPCL)M</sub>	Pulse duration, SPICLK low (clock p	0.5t <sub>c(SPC)M</sub> - 4	0.5t <sub>c(SPC)M</sub> + 4	ns		
3(4)	t <sub>w(SPCL)M</sub>	t <sub>w(SPCL)M</sub> Pulse duration, SPICLK low (clock polarity = 0)			0.5t <sub>c(SPC)M</sub> + 4		
3(-)	t <sub>w(SPCH)M</sub>	Pulse duration, SPICLK high (clock	llse duration, SPICLK high (clock polarity = 1)		0.5t <sub>c(SPC)M</sub> + 4	ns	
4 <sup>(4)</sup> SIN	t <sub>d(SPCH-</sub> SIMO)M	Delay time, SPISIMO valid before S polarity = 0)	PICLK low, (clock	0.5t <sub>c(SPC)M</sub> - 3			
	t <sub>d(SPCL-</sub> SIMO)M	Delay time, SPISIMO valid before S polarity = 1)	0.5t <sub>c(SPC)M</sub> - 3		ns		
$5^{(4)} \qquad \frac{t_{v(SPCL-}}{SIMO)M} \\ \frac{t_{v(SPCH-}}{t_{v(SPCH-}} \\ SIMO)M}$		Valid time, SPISIMO data valid after polarity = 0)	SPICLK low, (clock	0.5t <sub>c(SPC)M</sub> - 10.5		50	
		Valid time, SPISIMO data valid after polarity = 1)	0.5t <sub>c(SPC)M</sub> - 10.5		ns		
6 <sup>(5)</sup>	Setup time CS active until SPICLK	CSHOLD = 0	(C2TDELAY +2)*t <sub>c(VCLK)</sub> – 7.5	(C2TDELAY+2) * t <sub>c(VCLK)</sub> + 7			
	t <sub>C2TDELAY</sub>	high (clock polarity = 0)	CSHOLD = 1	(C2TDELAY +3) * t <sub>c(VCLK)</sub> – 7.5	(C2TDELAY+3) * t <sub>c(VCLK)</sub> + 7	ns	



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NO. <sup>(1)</sup> (2) (3)		PARAMETER		MIN	TYP MAX	UNIT
		Setup time CS active until SPICLK	CSHOLD = 0	(C2TDELAY +2)*t <sub>c(VCLK)</sub> – 7.5	(C2TDELAY+2) * t <sub>c(VCLK)</sub> + 7	
		(clock polarity = 1)	CSHOLD = 1	(C2TDELAY +3) * t <sub>c(VCLK)</sub> – 7.5	(C2TDELAY+3) * t <sub>c(VCLK)</sub> + 7	
<b>7</b> (5)	t	Hold time, SPICLK low until CS inac 0)	tive (clock polarity =	0.5*t <sub>c(SPC)M</sub> + (T2CDELAY + 1) *t <sub>c(VCLK)</sub> – 7	0.5*t <sub>c(SPC)M</sub> + (T2CDELAY + 1) * t <sub>c(VCLK)</sub> + 7.5	
	<sup>t</sup> T2CDELAY	Hold time, SPICLK high until CS inac 1)	ctive (clock polarity =	0.5*t <sub>c(SPC)M</sub> + (T2CDELAY + 1) *t <sub>c(VCLK)</sub> – 7	0.5*t <sub>c(SPC)M</sub> + (T2CDELAY + 1) * t <sub>c(VCLK)</sub> + 7.5	115
8(4)	t <sub>su(SOMI-</sub> SPCL)M	Setup time, SPISOMI before SPICLI (clock polarity = 0)	K low	5		ns
0. 7	t <sub>su(SOMI-</sub> SPCH)M	Setup time, SPISOMI before SPICLA (clock polarity = 1)	< high	5		115
<b>9</b> (4)	t <sub>h(SPCL-</sub> SOMI)M	Hold time, SPISOMI data valid after (clock polarity = 0)	SPICLK low	3		ns
9(4)	t <sub>h(SPCH-</sub> SOMI)M	Hold time, SPISOMI data valid after (clock polarity = 1)	SPICLK high	3		

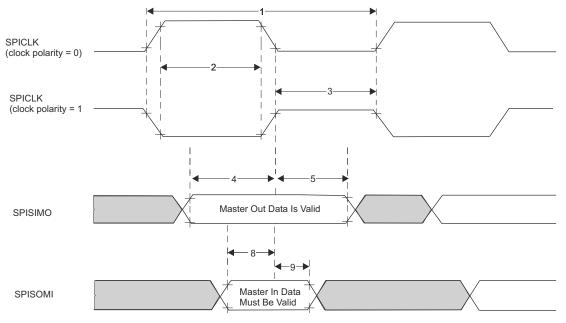
(1) The MASTER bit (SPIGCRx.0) is set and the CLOCK PHASE bit (SPIFMTx.16) is cleared (where x= 0 or 1).

(2)  $t_{c(MSS VCLK)}$  = master subsystem clock time = 1 /  $f_{(MSS VCLK)}$ . For more details, see the Technical Reference Manual.

(3) When the SPI is in Master mode, the following must be true: For PS values from 1 to 255: t<sub>c(SPC)M</sub> ≥ (PS +1)t<sub>c(MSS\_VCLK)</sub> ≥ 25ns, where PS is the prescale value set in the SPIFMTx.[15:8] register bits. For PS values of 0: t<sub>c(SPC)M</sub> = 2t<sub>c(MSS\_VCLK)</sub> ≥ 25ns.

(4) The active edge of the SPICLK signal referenced is controlled by the CLOCK POLARITY bit (SPIFMTx.17).

(5) C2TDELAY and T2CDELAY is programmed in the SPIDELAY register





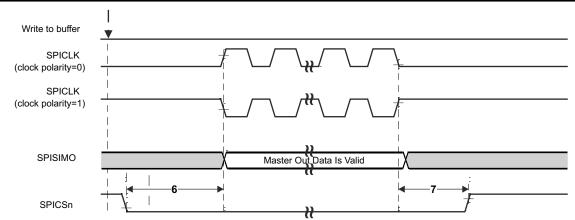


Figure 7-4. SPI Master Mode Chip Select Timing (CLOCK PHASE = 0)

# 7.10.3.2.3 SPI Master Mode Switching Parameters (CLOCK PHASE = 1, SPICLK = output, SPISIMO = output, and SPISOMI = input)

NO. <sup>(1)</sup> (2) (3)		PARAMETER		MIN	TYP MAX	UNIT
1	t <sub>c(SPC)M</sub>	Cycle time, SPICLK <sup>(4)</sup>		25	256t <sub>c(VCLK)</sub>	ns
2 <sup>(4)</sup>	t <sub>w(SPCH)M</sub>	Pulse duration, SPICLK high (clock p	oolarity = 0)	0.5t <sub>c(SPC)M</sub> - 4	0.5t <sub>c(SPC)M</sub> + 4	nc
2()	t <sub>w(SPCL)M</sub>	Pulse duration, SPICLK low (clock po	CLK low (clock polarity = 1)		0.5t <sub>c(SPC)M</sub> + 4	ns
3(4)	t <sub>w(SPCL)M</sub>	Pulse duration, SPICLK low (clock po	olarity = 0)	0.5t <sub>c(SPC)M</sub> - 4	0.5t <sub>c(SPC)M</sub> + 4	
3(1)	t <sub>w(SPCH)M</sub>	Pulse duration, SPICLK high (clock p	oolarity = 1)	0.5t <sub>c(SPC)M</sub> - 4	0.5t <sub>c(SPC)M</sub> + 4	ns
4 <sup>(4)</sup>	t <sub>d(SPCH-</sub> SIMO)M	Delay time, SPISIMO valid before SF = 0)	PICLK low, (clock polarity	0.5t <sub>c(SPC)M</sub> - 3		20
407	t <sub>d(SPCL-</sub> SIMO)M	Delay time, SPISIMO valid before SF polarity = 1)	PICLK high, (clock	0.5t <sub>c(SPC)M</sub> - 3		ns
5 <sup>(4)</sup>	t <sub>v(SPCL-</sub> SIMO)M	Valid time, SPISIMO data valid after polarity = 0)	SPICLK low, (clock	0.5t <sub>c(SPC)M</sub> – 10.5		
500	t <sub>v(SPCH-</sub> SIMO)M	Valid time, SPISIMO data valid after polarity = 1)	SPICLK high, (clock	0.5t <sub>c(SPC)M</sub> – 10.5		ns
	t <sub>C2TDELAY</sub>	Setup time CS active until SPICLK high (clock polarity = 0)	CSHOLD = 0	0.5*t <sub>c(SPC)M</sub> + (C2TDELAY + 2)*t <sub>c(VCLK)</sub> – 7	0.5*t <sub>c(SPC)M</sub> + (C2TDELAY +2) * t <sub>c(VCLK)</sub> + 7.5	
6 <sup>(5)</sup>			CSHOLD = 1	0.5*t <sub>c(SPC)M</sub> + (C2TDELAY + 2)*t <sub>c(VCLK)</sub> – 7	0.5*t <sub>c(SPC)M</sub> + (C2TDELAY +2) * t <sub>c(VCLK)</sub> + 7.5	
0(0)		Setup time CS active until SPICLK	CSHOLD = 0	0.5*t <sub>c(SPC)M</sub> + (C2TDELAY +2)*t <sub>c(VCLK)</sub> – 7	0.5*t <sub>c(SPC)M</sub> + (C2TDELAY +2) * t <sub>c(VCLK)</sub> + 7.5	ns
		low (clock polarity = 1)	CSHOLD = 1	0.5*t <sub>c(SPC)M</sub> + (C2TDELAY +3)*t <sub>c(VCLK)</sub> – 7	0.5*t <sub>c(SPC)M</sub> + (C2TDELAY +3) * t <sub>c(VCLK)</sub> + 7.5	
7 <sup>(5)</sup>	+	Hold time, SPICLK low until CS inact	ive (clock polarity = 0)	(T2CDELAY + 1) *t <sub>c(VCLK)</sub> – 7.5	(T2CDELAY + 1) *t <sub>c(VCLK)</sub> + 7	
	t <sub>T2CDELAY</sub>	Hold time, SPICLK high until CS inac	ctive (clock polarity = 1)	(T2CDELAY + 1) *t <sub>c(VCLK)</sub> – 7.5	(T2CDELAY + 1) *t <sub>c(VCLK)</sub> + 7	ns
8(4)	t <sub>su(SOMI-</sub> SPCL)M	Setup time, SPISOMI before SPICLk (clock polarity = 0)	Clow	5		ns



NO. <sup>(1)</sup> (2) (3)		PARAMETER		TYP	MAX	UNIT
	t <sub>su(SOMI-</sub> SPCH)M	Setup time, SPISOMI before SPICLK high (clock polarity = 1)	5			
9 <sup>(4)</sup>	t <sub>h(SPCL-</sub> SOMI)M	Hold time, SPISOMI data valid after SPICLK low (clock polarity = 0)	3			20
50	t <sub>h(SPCH-</sub> SOMI)M	Hold time, SPISOMI data valid after SPICLK high (clock polarity = 1)	3			ns

(1) The MASTER bit (SPIGCRx.0) is set and the CLOCK PHASE bit (SPIFMTx.16) is set (where x = 0 or 1).

(2)  $t_{c(MSS_VCLK)}$  = master subsystem clock time = 1 /  $f_{(MSS_VCLK)}$ . For more details, see the Technical Reference Manual.

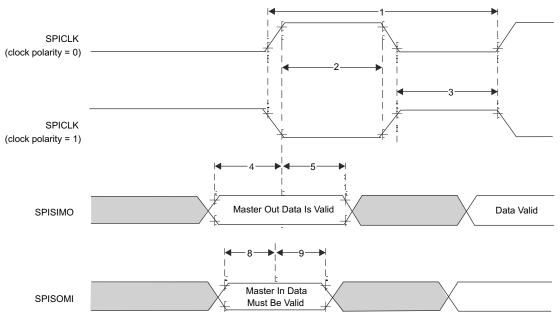
(a) When the SPI is in Master mode, the following must be true: For PS values from 1 to 255:  $t_{c(SPC)M} \ge (PS + 1)t_{c(MSS_VCLK)} \ge 25$  ns, where PS is the prescale value set in the SPIFMTx.[15:8] register bits. For PS values of 0:  $t_{c(SPC)M} \ge 2t_{c(MSS_VCLK)} \ge 25$  ns.

(4) The active edge of the SPICLK signal referenced is controlled by the CLOCK POLARITY bit (SPIFMTx.17).

(5) C2TDELAY and T2CDELAY is programmed in the SPIDELAY register

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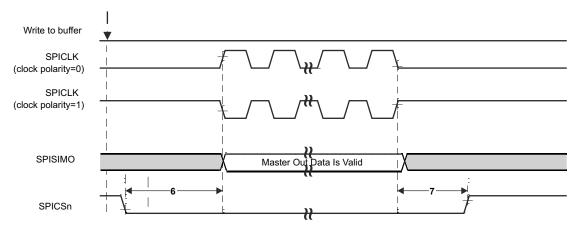


Figure 7-6. SPI Master Mode Chip Select Timing (CLOCK PHASE = 1)



#### 7.10.3.3 SPI Slave Mode I/O Timings

7.10.3.3.1 SPI Slave Mode Switching Parameters (SPICLK = input, SPISIMO = input, and SPISOMI = output) (1) (2) (3)

NO.		PARAMETER	MIN	ТҮР	MAX	UNIT	
1	t <sub>c(SPC)S</sub>	Cycle time, SPICLK <sup>(4)</sup>	25			ns	
2 <sup>(5)</sup>	t <sub>w(SPCH)S</sub>	Pulse duration, SPICLK high (clock polarity = 0)	10			ns	
2(-)	t <sub>w(SPCL)S</sub>	Pulse duration, SPICLK low (clock polarity = 1)	10			115	
3 <mark>(5)</mark>	t <sub>w(SPCL)S</sub>	Pulse duration, SPICLK low (clock polarity = 0)	10			20	
3(-)	t <sub>w(SPCH)S</sub>	Pulse duration, SPICLK high (clock polarity = 1)	10			ns	
4 <sup>(5)</sup>	t <sub>d(SPCH-SOMI)S</sub>	Delay time, SPISOMI valid after SPICLK high (clock polarity = 0)			10	20	
4(-)	t <sub>d(SPCL-SOMI)S</sub>	Delay time, SPISOMI valid after SPICLK low (clock polarity = 1)			10	ns	
5 <sup>(5)</sup>	t <sub>h(SPCH-SOMI)S</sub>	Hold time, SPISOMI data valid after SPICLK high (clock polarity = 0)	2			20	
5(0)	t <sub>h(SPCL-SOMI)S</sub>	Hold time, SPISOMI data valid after SPICLK low (clock polarity = 1)	2			ns	
4(5)	t <sub>d(SPCH-SOMI)S</sub>	Delay time, SPISOMI valid after SPICLK high (clock polarity = 0; clock phase = 0) OR (clock polarity = 1; clock phase = 1)			10		
4(0)	t <sub>d(SPCL</sub> -SOMI)S	Delay time, SPISOMI valid after SPICLK low (clock polarity = 1; clock phase = 0) OR (clock polarity = 0; clock phase = 1)			10	ns	
<b>E</b> (5)	t <sub>h(SPCH-SOMI)S</sub>	Hold time, SPISOMI data valid after SPICLK high (clock polarity = 0; clock phase = 0) OR (clock polarity = 1; clock phase = 1)	2			20	
3(-)	t <sub>h(SPCL</sub> -SOMI)S	Hold time, SPISOMI data valid after SPICLK low (clock polarity = 1; clock phase = 0) OR (clock polarity = 0; clock phase = 1)	2			ns	
<b>6</b> (5)	t <sub>su(SIMO-SPCL)</sub> S	Setup time, SPISIMO before SPICLK low (clock polarity = 0; clock phase = 0) OR (clock polarity = 1; clock phase = 1)	3			ns	
0.7	t <sub>su(SIMO-SPCH)</sub> S	Setup time, SPISIMO before SPICLK high (clock polarity = 1; clock phase = 0) OR (clock polarity = 0; clock phase = 1)	3			115	
7(5)	t <sub>h(SPCL</sub> -SIMO)S	Hold time, SPISIMO data valid after SPICLK low (clock polarity = 0; clock phase = 0) OR (clock polarity = 1; clock phase = 1)	1			nc	
(3)	t <sub>h(SPCL-SIMO)S</sub>	Hold time, SPISIMO data valid after SPICLK high (clock polarity = 1; clock phase = 0) OR (clock polarity = 0; clock phase = 1)	1			– ns	
4 <sup>(5)</sup> 5 <sup>(5)</sup> 6 <sup>(5)</sup> 7 <sup>(5)</sup>	<sup>u</sup> h(SPCL-SIMO)S		1				

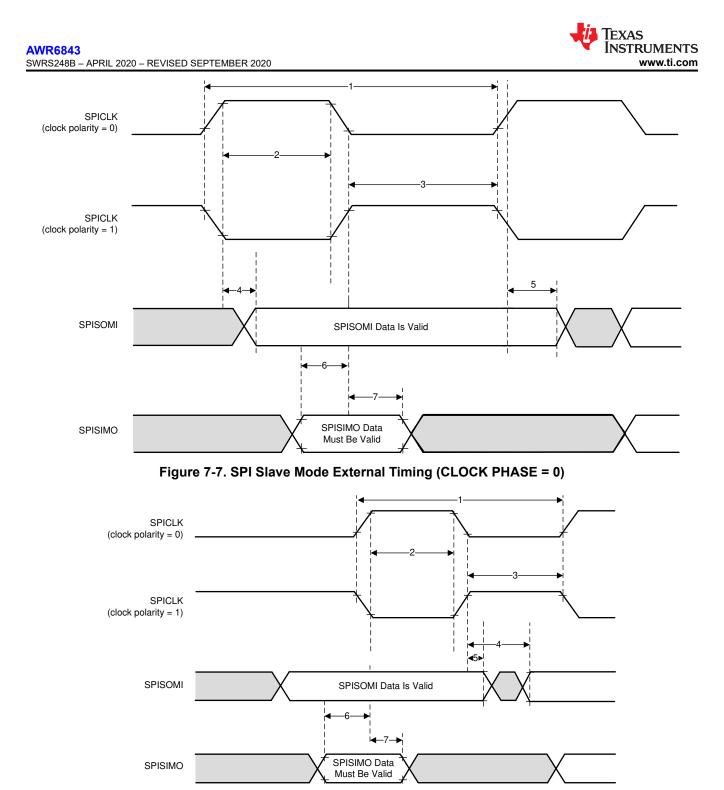
(1) The MASTER bit (SPIGCRx.0) is cleared (where x = 0 or 1).

(2) The CLOCK PHASE bit (SPIFMTx.16) is either cleared or set for CLOCK PHASE = 0 or CLOCK PHASE = 1 respectively.

(3)  $t_{c(MSS_VCLK)}$  = master subsystem clock time = 1 /  $f_{(MSS_VCLK)}$ . For more details, see the Technical Reference Manual.

(4) When the SPI is in Slave mode, the following must be true: For PS values from 1 to 255:  $t_{c(SPC)S} \ge (PS + 1)t_{c(MSS_VCLK)} \ge 25$  ns, where PS is the prescale value set in the SPIFMTx.[15:8] register bits.For PS values of 0:  $t_{c(SPC)S} = 2t_{c(MSS_VCLK)} \ge 25$  ns.

(5) The active edge of the SPICLK signal referenced is controlled by the CLOCK POLARITY bit (SPIFMTx.17).







#### 7.10.3.4 Typical Interface Protocol Diagram (Slave Mode)

- 1. Host should ensure that there is a delay of two SPI clocks between CS going low and start of SPI clock.
- 2. Host should ensure that CS is toggled for every 16 bits of transfer through SPI.

Figure 7-9 shows the SPI communication timing of the typical interface protocol.

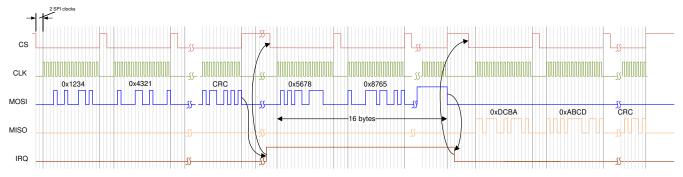


Figure 7-9. SPI Communication

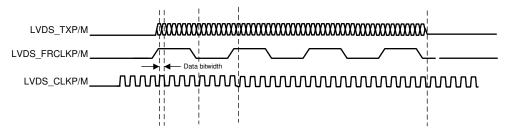


#### 7.10.4 LVDS Interface Configuration

The supported AWR6843 LVDS lane configuration is two Data lanes (LVDS\_TXP/M), one Bit Clock lane (LVDS\_CLKP/M) and one Frame clock lane (LVDS\_FRCLKP/M). The LVDS interface is used for debugging. The LVDS interface supports the following data rates:

- 900 Mbps (450 MHz DDR Clock)
- 600 Mbps (300 MHz DDR Clock)
- 450 Mbps (225 MHz DDR Clock)
- 400 Mbps (200 MHz DDR Clock)
- 300 Mbps (150 MHz DDR Clock)
- 225 Mbps (112.5 MHz DDR Clock)
- 150 Mbps (75 MHz DDR Clock)

Note that the bit clock is in DDR format and hence the numbers of toggles in the clock is equivalent to data.



#### Figure 7-10. LVDS Interface Lane Configuration And Relative Timings

#### 7.10.4.1 LVDS Interface Timings

#### Table 7-7. LVDS Electrical Characteristics

PARAMETER	TEST CONDITIONS	MIN	ΤΥΡ ΜΑΧ	UNIT
Duty Cycle Requirements	max 1 pF lumped capacitive load on LVDS lanes	48%	52%	
Output Differential Voltage	peak-to-peak single-ended with 100 $\Omega$ resistive load between differential pairs	250	450	mV
Output Offset Voltage		1125	1275	mV
Trise and Tfall	20%-80%, 900 Mbps		330	ps
Jitter (pk-pk)	900 Mbps		80	ps



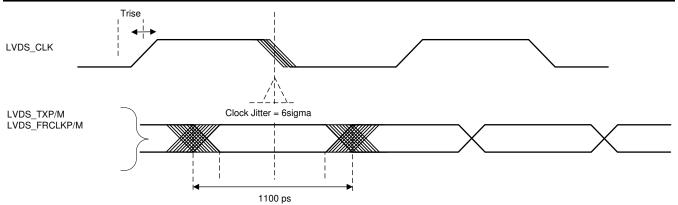


Figure 7-11. Timing Parameters

#### 7.10.5 General-Purpose Input/Output

Section 7.10.5.1 lists the switching characteristics of output timing relative to load capacitance.

## 7.10.5.1 Switching Characteristics for Output Timing versus Load Capacitance ( $C_L$ ) <sup>(1)</sup> <sup>(2)</sup>

	PARAMETER	TEST CONDITIONS		VIOIN = 1.8V	VIOIN = 3.3V	UNIT
			C <sub>L</sub> = 20 pF	2.8	3.0	
t <sub>r</sub>	Max rise time		C <sub>L</sub> = 50 pF	6.4	6.9	ns
		Slew control = 0	C <sub>L</sub> = 75 pF	9.4	10.2	
			C <sub>L</sub> = 20 pF	2.8	2.8	
t <sub>f</sub>	Max fall time		C <sub>L</sub> = 50 pF	6.4	6.6	ns
			C <sub>L</sub> = 75 pF	9.4	9.8	
			C <sub>L</sub> = 20 pF	3.3	3.3	
t <sub>r</sub>	Max rise time		C <sub>L</sub> = 50 pF	6.7	7.2	ns
		Slew control = 1	C <sub>L</sub> = 75 pF	9.6	10.5	
			C <sub>L</sub> = 20 pF	3.1	3.1	
t <sub>f</sub>	Max fall time		C <sub>L</sub> = 50 pF	6.6	6.6	ns
		C <sub>L</sub> = 75 p		9.6	9.6	

(1) Slew control, which is configured by PADxx\_CFG\_REG, changes behavior of the output driver (faster or slower output slew rate).

(2) The rise/fall time is measured as the time taken by the signal to transition from 10% and 90% of VIOIN voltage.



#### 7.10.6 Controller Area Network - Flexible Data-rate (CAN-FD)

The CAN-FD module supports both classic CAN and CAN FD (CAN with Flexible Data-Rate) specifications. CAN FD feature allows high throughput and increased payload per data frame. The classic CAN and CAN FD devices can coexist on the same network without any conflict.

The CAN-FD has the following features:

- Conforms with CAN Protocol 2.0 A, B and ISO 11898-1
- Full CAN FD support (up to 64 data bytes per frame)
- AUTOSAR and SAE J1939 support
- Up to 32 dedicated Transmit Buffers
- Configurable Transmit FIFO, up to 32 elements
- · Configurable Transmit Queue, up to 32 elements
- · Configurable Transmit Event FIFO, up to 32 elements
- Up to 64 dedicated Receive Buffers
- Two configurable Receive FIFOs, up to 64 elements each
- Up to 128 11-bit filter elements
- · Internal Loopback mode for self-test
- Mask-able interrupts, two interrupt lines
- Two clock domains (CAN clock / Host clock)
- Parity / ECC support Message RAM single error correction and double error detection (SECDED) mechanism
- Full Message Memory capacity (4352 words).

#### 7.10.6.1 Dynamic Characteristics for the CANx TX and RX Pins

PARAMETER		MIN	ТҮР	MAX	UNIT
t <sub>d(CAN_FD_tx)</sub>	Delay time, transmit shift register to CAN_FD_tx pin <sup>(1)</sup>			15	ns
t <sub>d(CAN_FD_rx)</sub>	Delay time, CAN_FD_rx pin to receive shift register <sup>(1)</sup>			10	ns

(1) These values do not include rise/fall times of the output buffer.

#### 7.10.7 Serial Communication Interface (SCI)

The SCI has the following features:

- Standard universal asynchronous receiver-transmitter (UART) communication
- Standard non-return to zero (NRZ) format
- · Double-buffered receive and transmit functions
- · Asynchronous or iso-synchronous communication modes with no CLK pin
- Capability to use Direct Memory Access (DMA) for transmit and receive data
- Two external pins: RS232\_RX and RS232\_TX

#### 7.10.7.1 SCI Timing Requirements

		MIN	TYP	MAX	UNIT
f(baud)	Supported baud rate at 20 pF		921.6		kHz



#### 7.10.8 Inter-Integrated Circuit Interface (I2C)

The inter-integrated circuit (I2C) module is a multimaster communication module providing an interface between devices compliant with Philips Semiconductor I2C-bus specification version 2.1 and connected by an I<sup>2</sup>C-bus<sup>™</sup>. This module will support any slave or master I2C compatible device.

The I2C has the following features:

- Compliance to the Philips I2C bus specification, v2.1 (The I2C Specification, Philips document number 9398 393 40011)
  - Bit/Byte format transfer
  - 7-bit and 10-bit device addressing modes
  - General call
  - START byte
  - Multi-master transmitter/ slave receiver mode
  - Multi-master receiver/ slave transmitter mode
  - Combined master transmit/receive and receive/transmit mode
  - Transfer rates of 100 kbps up to 400 kbps (Phillips fast-mode rate)
- Free data format
- Two DMA events (transmit and receive)
- DMA event enable/disable capability
- Module enable/disable capability
- The SDA and SCL are optionally configurable as general purpose I/O
- Slew rate control of the outputs
- Open drain control of the outputs
- Programmable pullup/pulldown capability on the inputs
- Supports Ignore NACK mode

#### Note

This I2C module does not support:

- High-speed (HS) mode
- C-bus compatibility mode
- The combined format in 10-bit address mode (the I2C sends the slave address second byte every time it sends the slave address first byte)



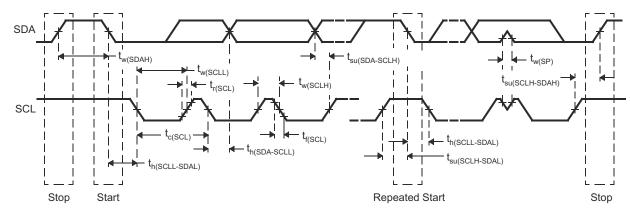
#### 7.10.8.1 I2C Timing Requirements

	(1)	STANDARD	MODE	FAST MO	DE	UNIT
		MIN	MAX	MIN	MAX	
t <sub>c(SCL)</sub>	Cycle time, SCL	10		2.5		μs
$t_{su(SCLH-SDAL)}$	Setup time, SCL high before SDA low (for a repeated START condition)	4.7		0.6		μs
$t_{h(SCLL-SDAL)}$	Hold time, SCL low after SDA low (for a START and a repeated START condition)	4		0.6		μs
t <sub>w(SCLL)</sub>	Pulse duration, SCL low	4.7		1.3		μs
t <sub>w(SCLH)</sub>	Pulse duration, SCL high	4		0.6		μs
t <sub>su(SDA-SCLH)</sub>	Setup time, SDA valid before SCL high	250		100		μs
t <sub>h(SCLL-SDA)</sub>	Hold time, SDA valid after SCL low	0	3.45 <sup>(1)</sup>	0	0.9	μs
t <sub>w(SDAH)</sub>	Pulse duration, SDA high between STOP and START conditions	4.7		1.3		μs
$t_{su(SCLH-SDAH)}$	Setup time, SCL high before SDA high (for STOP condition)	4		0.6		μs
t <sub>w(SP)</sub>	Pulse duration, spike (must be suppressed)			0	50	ns
C <sub>b</sub> <sup>(2) (3)</sup>	Capacitive load for each bus line		400		400	pF

(1) The I2C pins SDA and SCL do not feature fail-safe I/O buffers. These pins could potentially draw current when the device is powered down.

(2) The maximum th(SDA-SCLL) for I2C bus devices has only to be met if the device does not stretch the low period (tw(SCLL)) of the SCL signal.

(3) C<sub>b</sub> = total capacitance of one bus line in pF. If mixed with fast-mode devices, faster fall-times are allowed.





#### Note

- A device must internally provide a hold time of at least 300 ns for the SDA signal (referred to the VIHmin of the SCL signal) to bridge the undefined region of the falling edge of SCL.
- The maximum th(SDA-SCLL) has only to be met if the device does not stretch the LOW period (tw(SCLL)) of the SCL signal. E.A Fast-mode I2C-bus device can be used in a Standard-mode I2C-bus system, but the requirement  $t_{su(SDA-SCLH)} \ge 250$  ns must then be met. This will automatically be the case if the device does not stretch the LOW period of the SCL signal. If such a device does stretch the LOW period of the SCL signal, it must output the next data bit to the SDA line tr max +  $t_{su(SDA-SCLH)}$ .



#### 7.10.9 Quad Serial Peripheral Interface (QSPI)

The quad serial peripheral interface (QSPI) module is a kind of SPI module that allows single, dual, or quad read access to external SPI devices. This module has a memory mapped register interface, which provides a direct interface for accessing data from external SPI devices and thus simplifying software requirements. The QSPI works as a master only. The QSPI in the device is primarily intended for fast booting from quad-SPI flash memories.

The QSPI supports the following features:

- Programmable clock divider
- · Six-pin interface
- Programmable length (from 1 to 128 bits) of the words transferred
- Programmable number (from 1 to 4096) of the words transferred
- Support for 3-, 4-, or 6-pin SPI interface
- Optional interrupt generation on word or frame (number of words) completion
- Programmable delay between chip select activation and output data from 0 to 3 QSPI clock cycles

Section 7.10.9.2 and Section 7.10.9.3 assume the operating conditions stated in Section 7.10.9.1.

#### 7.10.9.1 QSPI Timing Conditions

		MIN	TYP MAX	UNIT	
Input Cond	ditions				
t <sub>R</sub>	Input rise time	1	3	ns	
t <sub>F</sub>	Input fall time	1	3	ns	
Output Co	nditions				
C <sub>LOAD</sub>	Output load capacitance	2	15	pF	

#### 7.10.9.2 Timing Requirements for QSPI Input (Read) Timings

Clock Mode 0 (clk polarity = 0; clk phase = 0) is the mode of operation. (1)

		MIN	TYP	MAX	UNIT
t <sub>su(D-SCLK)</sub>	Setup time, d[3:0] valid before falling sclk edge	7.3			ns
t <sub>h(SCLK-D)</sub>	Hold time, d[3:0] valid after falling sclk edge	1.5			ns
t <sub>su(D-SCLK)</sub>	Setup time, final d[3:0] bit valid before final falling sclk edge	7.3 – P <sup>(2)</sup>			ns
t <sub>h(SCLK-D)</sub>	Hold time, final d[3:0] bit valid after final falling sclk edge	1.5 + P <sup>(2)</sup>			ns

(1) The Device captures data on the falling clock edge in Clock Mode 0, as opposed to the traditional rising clock edge. Although nonstandard, the falling-edge-based setup and hold time timings have been designed to be compatible with standard SPI devices that launch data on the falling edge in Clock Mode 0.

(2) P = SCLK period in ns.



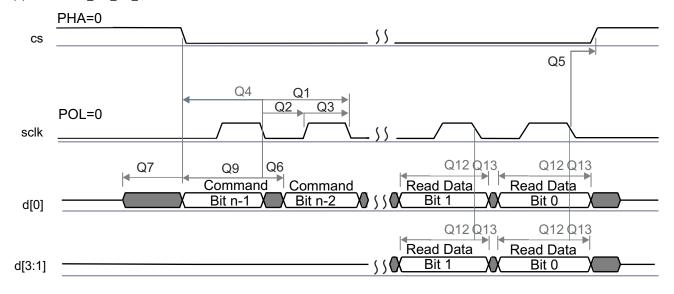
#### 7.10.9.3 QSPI Switching Characteristics

NO.		PARAMETER	MIN	TYP MAX	UNIT
Q1	t <sub>c(SCLK)</sub>	Cycle time, sclk	12.5		ns
Q2	t <sub>w(SCLKL)</sub>	Pulse duration, sclk low	Y*P – 3 <sup>(1)</sup> (2)		ns
Q3	t <sub>w(SCLKH)</sub>	Pulse duration, sclk high	Y*P – 3 <sup>(1)</sup>		ns
Q4	t <sub>d(CS-SCLK)</sub>	Delay time, sclk falling edge to cs active edge	-M*P - 1 <sup>(1) (3)</sup>	-M*P + 2.5 <sup>(1)</sup> (3)	ns
Q5	t <sub>d(SCLK-CS)</sub>	Delay time, sclk falling edge to cs inactive edge	N*P – 1 <sup>(1) (3)</sup>	N*P + 2.5 <sup>(1)</sup> (3)	ns
Q6	t <sub>d(SCLK-D1)</sub>	Delay time, sclk falling edge to d[1] transition	-3.5	7	ns
Q7	t <sub>ena(CS-D1LZ)</sub>	Enable time, cs active edge to d[1] driven (lo-z)	-P - 4 <sup>(3)</sup>	–P +1 <sup>(3)</sup>	ns
Q8	t <sub>dis(CS-D1Z)</sub>	Disable time, cs active edge to d[1] tri-stated (hi-z)	$-P - 4^{(3)}$	–P +1 <sup>(3)</sup>	ns
Q9	t <sub>d(SCLK-D1)</sub>	Delay time, sclk first falling edge to first d[1] transition (for PHA = 0 only)	$-3.5 - P^{(3)}$	7 – P <sup>(3)</sup>	ns
Q12	t <sub>su(D-SCLK)</sub>	Setup time, d[3:0] valid before falling sclk edge	7.3		ns
Q13	t <sub>h(SCLK-D)</sub>	Hold time, d[3:0] valid after falling sclk edge	1.5		ns
Q14	t <sub>su(D-SCLK)</sub>	Setup time, final d[3:0] bit valid before final falling sclk edge	7.3 — P <sup>(3)</sup>		ns
Q15	t <sub>h(SCLK-D)</sub>	Hold time, final d[3:0] bit valid after final falling sclk edge	1.5 + P <sup>(3)</sup>		ns

(1) The Y parameter is defined as follows: If DCLK\_DIV is 0 or ODD then, Y equals 0.5. If DCLK\_DIV is EVEN then, Y equals (DCLK\_DIV/ 2) / (DCLK\_DIV+1). For best performance, it is recommended to use a DCLK\_DIV of 0 or ODD to minimize the duty cycle distortion. All required details about clock division factor DCLK\_DIV can be found in the device-specific Technical Reference Manual.

(2) P = SCLK period in ns.

(3) M = QSPI\_SPI\_DC\_REG.DDx + 1, N = 2



SPRS85v\_TIMING\_OSPI1\_02

Figure 7-13. QSPI Read (Clock Mode 0)

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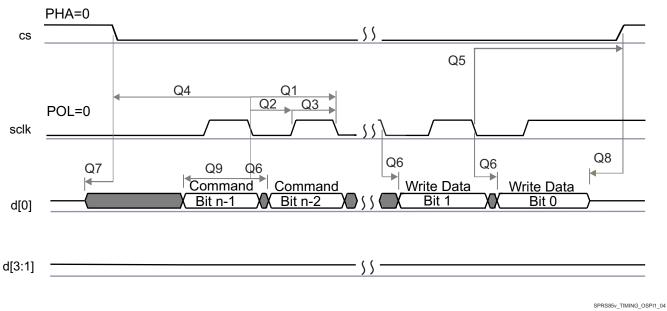


Figure 7-14. QSPI Write (Clock Mode 0)



#### 7.10.10 ETM Trace Interface

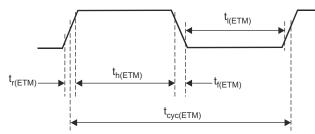
Section 7.10.10.2 and List item. assume the recommended operating conditions stated in Section 7.10.10.1.

#### 7.10.10.1 ETMTRACE Timing Conditions

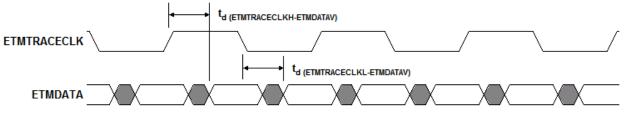
		MIN	TYP MAX	UNIT
Output Cond	litions			
C <sub>LOAD</sub>	Output load capacitance	2	20	pF

#### 7.10.10.2 ETM TRACE Switching Characteristics

NO.		PARAMETER	MIN	TYP MAX	UNIT
1	t <sub>cyc(ETM)</sub>	Cycle time, TRACECLK period	20		ns
2	t <sub>h(ETM)</sub>	Pulse Duration, TRACECLK High	9		ns
3	t <sub>I(ETM)</sub>	Pulse Duration, TRACECLK Low	9		ns
4	t <sub>r(ETM)</sub>	Clock and data rise time		3.3	ns
5	t <sub>f(ETM)</sub>	Clock and data fall time		3.3	ns
6	t <sub>d(ETMTRACE</sub> CLKH- ETMDATAV)	Delay time, ETM trace clock high to ETM data valid	1	7	ns
7	t <sub>d(ETMTRACE</sub> CLKI- ETMDATAV)	Delay time, ETM trace clock low to ETM data valid	1	7	ns



#### Figure 7-15. ETMTRACECLKOUT Timing



## Figure 7-16. ETMDATA Timing



#### 7.10.11 Data Modification Module (DMM)

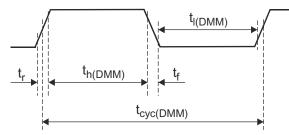
A Data Modification Module (DMM) gives the ability to write external data into the device memory.

The DMM has the following features:

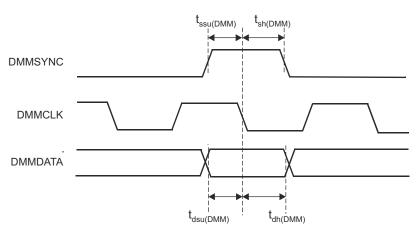
- · Acts as a bus master, thus enabling direct writes to the 4GB address space without CPU intervention
- Writes to memory locations specified in the received packet (leverages packets defined by trace mode of the RAM trace port [RTP] module)
- Writes received data to consecutive addresses, which are specified by the DMM (leverages packets defined by direct data mode of RTP module)
- Configurable port width (1, 2, 4, 8 pins)
- Up to 100 Mbit/s pin data rate

#### 7.10.11.1 DMM Timing Requirements

		MIN	TYP MAX	UNIT
t <sub>cyc(DMM)</sub>	Clock period	10		ns
t <sub>R</sub>	Clock rise time	1	3	ns
t <sub>F</sub>	Clock fall time	1	3	ns
t <sub>h(DMM)</sub>	High pulse width	6		ns
t <sub>I(DMM)</sub>	Low pulse width	6		ns
t <sub>ssu(DMM)</sub>	SYNC active to clk falling edge setup time	2		ns
t <sub>sh(DMM)</sub>	DMM clk falling edge to SYNC deactive hold time	3		ns
t <sub>dsu(DMM)</sub>	DATA to DMM clk falling edge setup time	2		ns
t <sub>dh(DMM)</sub>	DMM clk falling edge to DATA hold time	3		ns



#### Figure 7-17. DMMCLK Timing







#### 7.10.12 JTAG Interface

Section 7.10.12.2 and Section 7.10.12.3 assume the operating conditions stated in Section 7.10.12.1.

#### 7.10.12.1 JTAG Timing Conditions

			MIN	TYP MAX	UNIT
Input Cond	Input Conditions				
t <sub>R</sub>	Input rise time		1	3	ns
t <sub>F</sub>	Input fall time		1	3	ns
Output Conditions					
C <sub>LOAD</sub>	Output load capacitance		2	15	pF

#### 7.10.12.2 Timing Requirements for IEEE 1149.1 JTAG

NO.			MIN	TYP	MAX	UNIT
1	t <sub>c(TCK)</sub>	Cycle time TCK	66.66			ns
1a	t <sub>w(TCKH)</sub>	Pulse duration TCK high (40% of tc)	26.67			ns
1b	t <sub>w(TCKL)</sub>	Pulse duration TCK low(40% of tc)	26.67			ns
3	t <sub>su(TDI-TCK)</sub>	Input setup time TDI valid to TCK high	2.5			ns
5	t <sub>su(TMS-TCK)</sub>	Input setup time TMS valid to TCK high	2.5			ns
4	t <sub>h(TCK-TDI)</sub>	Input hold time TDI valid from TCK high	18			ns
4	t <sub>h(TCK-TMS)</sub>	Input hold time TMS valid from TCK high	18			ns

#### 7.10.12.3 Switching Characteristics Over Recommended Operating Conditions for IEEE 1149.1 JTAG

NO.		MIN	TYP MAX	UNIT	
2	t <sub>d(TCKL-TDOV)</sub>	0	25	ns	
				SPRS91v_JTAG_01	

Figure 7-19. JTAG Timing

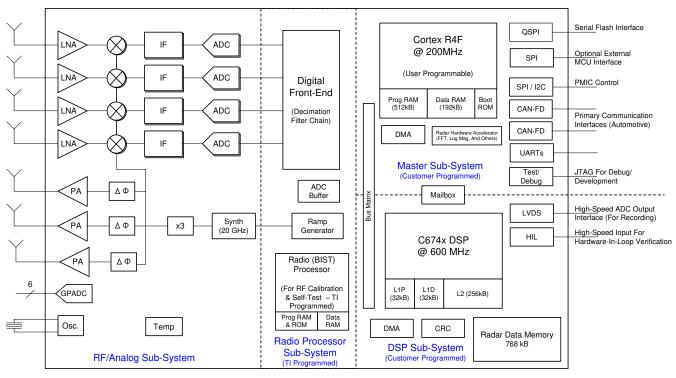


## 8 Detailed Description

#### 8.1 Overview

The AWR6843 device includes the entire Millimeter Wave blocks and analog baseband signal chain for two transmitters and four receivers, as well as a customer-programmable MCU. This device is applicable as a radaron-a-chip in use-cases with modest requirements for memory, processing capacity, and application code size. These could be cost-sensitive automotive applications that are evolving from 24-GHz narrowband implementation and some emerging simple ultra-short-range radar applications. Typical application examples for this device include: child presence detection, occupant detection, seat belt reminder, gesture detection, driver vital sign monitoring.

In terms of scalability, the AWR6843 device could be paired with a low-end external MCU, to address more complex applications that might require additional memory for larger application software footprint and faster interfaces. Because the AWR6843 device also provides high speed data interfaces like Serial-LVDS, it is suitable for interfacing with more capable external processing blocks. Here system designers can choose the AWR6843 to provide raw ADC data.



### 8.2 Functional Block Diagram

Figure 8-1. Functional Block Diagram



#### 8.3 Subsystems

#### 8.3.1 RF and Analog Subsystem

The RF and analog subsystem includes the RF and analog circuitry – namely, the synthesizer, PA, LNA, mixer, IF, and ADC. This subsystem also includes the crystal oscillator and temperature sensors. The three transmit channels can be operated up to a maximum of two at a time (simultaneously) in 1.3-V mode. The three Transmit channels simultaneous operation is supported only with 1-V LDO bypass and PA LDO disabled mode for transmit beamforming purpose, as required. In this mode, the 1-V supply needs to be fed on the VIN\_13RF1, VIN\_13RF2, and VOUT PA pin; whereas, the four receive channels can all be operated simultaneously.



#### 8.3.1.1 Clock Subsystem

The AWR6843 clock subsystem generates 60 to 64 GHz from an input reference of 40-MHz crystal. It has a built-in oscillator circuit followed by a clean-up PLL and a RF synthesizer circuit. The output of the RF synthesizer is then processed by an X3 multiplier to create the required frequency in the 60 to 64 GHz spectrum. The RF synthesizer output is modulated by the timing engine block to create the required waveforms for effective sensor operation.

The clean-up PLL also provides a reference clock for the host processor after system wakeup.

The clock subsystem also has built-in mechanisms for detecting the presence of a crystal and monitoring the quality of the generated clock.

Figure 8-2 describes the clock subsystem.

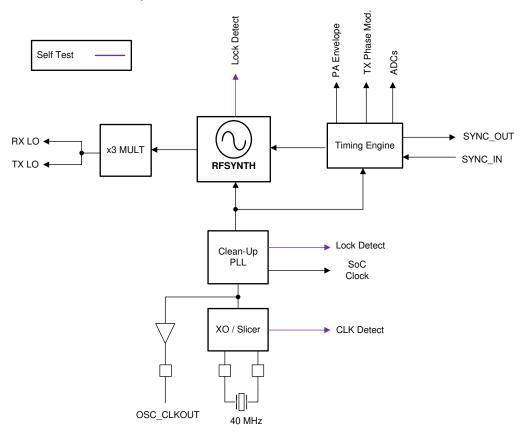


Figure 8-2. Clock Subsystem





#### 8.3.1.2 Transmit Subsystem

The AWR6843 transmit subsystem consists of three parallel transmit chains, each with independent phase and amplitude control. The device supports 6-bit linear phase modulation for MIMO radar.

The transmit chains also support programmable backoff for system optimization.

Figure 8-3 describes the transmit subsystem.

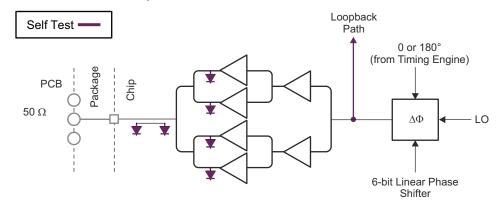


Figure 8-3. Transmit Subsystem (Per Channel)

#### 8.3.1.3 Receive Subsystem

The AWR6843 receive subsystem consists of four parallel channels. A single receive channel consists of an LNA, mixer, IF filtering, A2D conversion, and decimation. All four receive channels can be operational at the same time an individual power-down option is also available for system optimization.

Unlike conventional real-only receivers, the AWR6843 device supports a complex baseband architecture, which uses quadrature mixer and dual IF and ADC chains to provide complex I and Q outputs for each receiver channel. The AWR6843 is targeted for fast chirp systems. The band-pass IF chain has configurable lower cutoff frequencies above 175 kHz and can support bandwidths up to 10 MHz.

Figure 8-4 describes the receive subsystem.

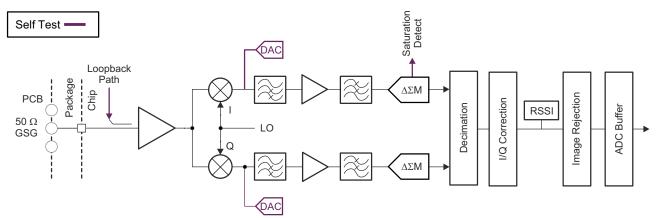


Figure 8-4. Receive Subsystem (Per Channel)



#### 8.3.2 Processor Subsystem

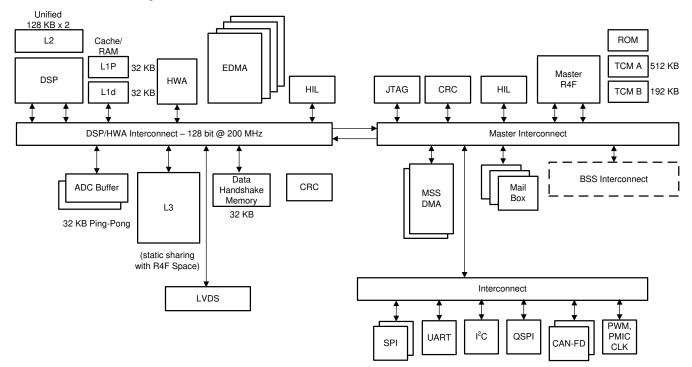


Figure 8-5. Processor Subsystem

Figure 8-5shows the block diagram for customer programmable processor subsystems in the AWR6843 device. At a high level there are two customer programmable subsystems, as shown separated by a dotted line in the diagram. Left hand side shows the DSP Subsystem which contains TI's high-performance C674x DSP, hardware accelerator, a high-bandwidth interconnect for high performance (128-bit, 200MHz), and associated peripherals – four DMAs for data transfer,

LVDS interface for Measurement data output, L3 Radar data cube memory, ADC buffers, CRC engine, and data handshake memory (additional memory provided on interconnect).

The right side of the diagram shows the Master subsystem. Master subsystem as name suggests is the master of the device and controls all the device peripherals and house-keeping activities of the device. Master subsystem contains Cortex-R4F (Master R4F) processor and associated peripherals and house-keeping components such as DMAs, CRC and Peripherals (I<sup>2</sup>C, UART, SPIs, CAN, PMIC clocking module, PWM, and others) connected to Master Interconnect through Peripheral Central Resource (PCR interconnect).

Details of the DSP CPU core can be found at http://www.ti.com/product/TMS320C6748.

HIL module is shown in both the subsystems and can be used to perform the radar operations feeding the captured data from outside into the device without involving the RF subsystem. HIL on master SS is for controlling the configuration and HIL on DSPSS for high speed ADC data input to the device. Both HIL modules uses the same IOs on the device, one additional IO (DMM\_MUX\_IN) allows selecting either of the two.

#### 8.3.3 Automotive Interface

The AWR6843 communicates with the automotive network over the following main interfaces:

• 2 CAN-FD modules



#### 8.3.4 Host Interface

The host interface can be provided through a SPI, UART, or CAN-FD interface. In some cases the serial interface for automotive applications is transcoded to a different serial standard.

This device communicates with the host radar processor over the following main interfaces:

- Reference Clock Reference clock available for host processor after device wakeup
- Control 4-port standard SPI (slave) for host control. All radio control commands (and response) flow through this interface.
- Reset Active-low reset for device wakeup from host
- Host Interrupt an indication that the mmwave sensor needs host interface
- Error Used for notifying the host in case the radio controller detects a fault

#### 8.3.5 Master Subsystem Cortex-R4F

The master system includes an ARM Cortex R4F processor, clock with a maximum operating frequency of 200 MHz. User applications executing on this processor control the overall operation of the device, including radar control through well-defined API messages, radar signal processing (assisted by the radar hardware accelerator), and peripherals for external interfaces.

See the Technical Reference Manual for a complete description and memory map.

#### 8.3.6 DSP Subsystem

The DSP subsystem includes TI's standard TMS320C674x megamodule and several blocks of internal memory (L1P, L1D, and L2). For complete information including memory map, please refer to Technical Reference Manual.

#### 8.3.7 Hardware Accelerator

The Radar Hardware Accelerator (HWA) is an IP that enables off-loading the burden of certain frequently used computations in FMCW radar signal processing from the main processor. FMCW radar signal processing involves the use of FFT and Log-Magnitude computations to obtain a radar image across the range, velocity, and angle dimensions. Some of the frequently used functions in FMCW radar signal processing can be done within the radar hardware accelerator, while still retaining the flexibility of implementing other proprietary algorithms in the main processor. See the Radar Hardware Accelerator User's Guide for a functional description and features of this module and see the Technical Reference Manual for a complete list of register and memory map.

#### 8.4 Other Subsystems

#### 8.4.1 ADC Channels (Service) for User Application

The AWR6843 device includes provision for an ADC service for user application, where the

GPADC engine present inside the device can be used to measure up to six external voltages. The ADC1, ADC2, ADC3, ADC4, ADC5, and ADC6 pins are used for this purpose.

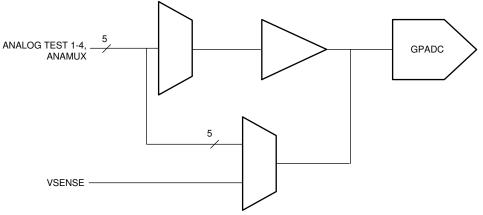
- ADC itself is controlled by TI firmware running inside the BIST subsystem and access to it for customer's
  external voltage monitoring purpose is via 'monitoring API' calls routed to the BIST subsystem. This API
  could be linked with the user application running on the Master R4.
- BIST subsystem firmware will internally schedule these measurements along with other RF and Analog monitoring operations. The API allows configuring the settling time (number of ADC samples to skip) and number of consecutive samples to take. At the end of a frame, the minimum, maximum and average of the readings will be reported for each of the monitored voltages.

**GPADC** Specifications:

- 625 Ksps SAR ADC
- 0 to 1.8V input range
- 10-bit resolution



• For 5 out of the 6 inputs, an optional internal buffer (0.4-1.4V input range) is available. Without the buffer, the ADC has a switched capacitor input load modeled with 5pF of sampling capacitance and 12pF parasitic capacitance (GPADC channel 6, the internal buffer is not available).



A. GPADC structures are used for measuring the output of internal temperature sensors. The accuracy of these measurements is ±7°C.

#### Figure 8-6. ADC Path

#### 8.4.1.1 GP-ADC Parameter

PARAMETER	ТҮР	UNIT
ADC supply	1.8	V
ADC unbuffered input voltage range	0 - 1.8	V
ADC buffered input voltage range <sup>(1)</sup>	0.4 – 1.3	V
ADC resolution	10	bits
ADC offset error	±5	LSB
ADC gain error	±5	LSB
ADC DNL	-1/+2.5	LSB
ADC INL	±2.5	LSB
ADC sample rate <sup>(2)</sup>	625	Ksps
ADC sampling time <sup>(2)</sup>	400	ns
ADC internal cap	10	pF
ADC buffer input capacitance	2	pF
ADC input leakage current	3	uA

(1) Outside of given range, the buffer output will become nonlinear.

(2) ADC itself is controlled by TI firmware running inside the BIST subsystem. For more details please refer to the API calls.



## 9 Monitoring and Diagnostics

#### 9.1 Monitoring and Diagnostic Mechanisms

Table 9-1 is a list of the main monitoring and diagnostic mechanisms available in the Functional Safety-Compliant targeted devices

NO	FEATURE	DESCRIPTION
1	Boot time LBIST For Master R4F Core and associated VIM	Device architecture supports hardware logic BIST (LBIST) engine self-test Controller (STC). This logic is used to provide a very high diagnostic coverage (>90%) on the Master R4F CPU core and Vectored Interrupt Module (VIM) at a transistor level. LBIST for the CPU and VIM need to be triggered by application code before starting the functional safety application. CPU stays there in while loop and does not proceed further if a fault is identified.
2	Boot time PBIST for Master R4F TCM Memories	Master R4F has three Tightly coupled Memories (TCM) memories TCMA, TCMB0 and TCMB1. Device architecture supports a hardware programmable memory BIST (PBIST) engine. This logic is used to provide a very high diagnostic coverage (March-13n) on the implemented Master R4F TCMs at a transistor level. PBIST for TCM memories is triggered by Bootloader at the boot time before starting download of application from Flash or peripheral interface. CPU stays there in while loop and does not proceed further if a fault is identified.
3	End to End ECC for Master R4F TCM Memories	TCMs diagnostic is supported by Single error correction double error detection (SECDED) ECC diagnostic. An 8-bit code word is used to store the ECC data as calculated over the 64- bit data bus. ECC evaluation is done by the ECC control logic inside the CPU. This scheme provides end-to-end diagnostics on the transmissions between CPU and TCM. CPU can be configured to have predetermined response (Ignore or Abort generation) to single and double bit error conditions.
4	Master R4F TCM bit multiplexing	Logical TCM word and its associated ECC code is split and stored in two physical SRAM banks. This scheme provides an inherent diagnostic mechanism for address decode failures in the physical SRAM banks. Faults in the bank addressing are detected by the CPU as an ECC fault. Further, bit multiplexing scheme implemented such that the bits accessed to generate a logical (CPU) word are not physically adjacent. This scheme helps to reduce the probability of physical multi-bit faults resulting in logical multi-bit faults; rather they manifest as multiple single bit faults. As the SECDED TCM ECC can correct a single bit fault in a logical word, this scheme improves the usefulness of the TCM ECC diagnostic. Both these features are hardware features and cannot be enabled or disabled by application software.
5	Clock Monitor	Device architecture supports Three Digital Clock Comparators (DCCs) and an internal RCOSC. Dual functionality is provided by these modules – Clock detection and Clock Monitoring. DCCint is used to check the availability/range of Reference clock at boot otherwise the device is moved into limp mode (Device still boots but on 10MHz RCOSC clock source. This provides debug capability). DCCint is only used by boot loader during boot time. It is disabled once the APLL is enabled and locked. DCC1 is dedicated for APLL lock detection monitoring, comparing the APLL output divided version with the Reference input clock of the device. Initially (before configuring APLL), DCC1 is used by bootloader to identify the precise frequency of reference input clock against the internal RCOSC clock source. Failure detection for DCC1 would cause the device to go into limp mode. DCC2 module is one which is available for user software . From the list of clock options given in detailed spec, any two clocks can be compared. One example usage is to compare the CPU clock with the Reference or internal RCOSC clock source. Failure detection is indicated to the Master R4F CPU via Error Signaling Module (ESM).

#### Table 9-1. Monitoring and Diagnostic Mechanisms for Functional Safety-Compliant Targeted Devices



#### Table 9-1. Monitoring and Diagnostic Mechanisms for Functional Safety-Compliant Targeted Devices (continued)

NO	FEATURE	DESCRIPTION
7	RTI/WD for Master R4F	Device architecture supports the use of an internal watchdog that is implemented in the real- time interrupt (RTI) module. The internal watchdog has two modes of operation: digital watchdog (DWD) and digital windowed watchdog (DWWD). The modes of operation are mutually exclusive; the designer can elect to use one mode or the other but not both at the same time. Watchdog can issue either an internal (warm) system reset or a CPU non-mask able interrupt upon detection of a failure. The Watchdog is enabled by the bootloader in DWD mode at boot time to track the boot process. Once the application code takes up the control, Watchdog can be configured again for mode and timings based on specific customer requirements.
8	MPU for Master R4F	Cortex-R4F CPU includes an MPU. The MPU logic can be used to provide spatial separation of software tasks in the device memory. Cortex-R4F MPU supports 12 regions. It is expected that the operating system controls the MPU and changes the MPU settings based on the needs of each task. A violation of a configured memory protection policy results in a CPU abort.
9	PBIST for Peripheral interface SRAMs - SPIs, CANs	Device architecture supports a hardware programmable memory BIST (PBIST) engine for Peripheral SRAMs as well. PBIST for peripheral SRAM memories can be triggered by the application. User can elect to run the PBIST on one SRAM or on groups of SRAMs based on the execution time, which can be allocated to the PBIST diagnostic. The PBIST tests are destructive to memory contents, and as such are typically run only at boot time. However, the user has the freedom to initiate the tests at any time if peripheral communication can be hindered. Any fault detected by the PBIST results in an error indicated in PBIST status registers.
10	ECC for Peripheral interface SRAMs – SPIs, CANs	Peripheral interface SRAMs diagnostic is supported by Single error correction double error detection (SECDED) ECC diagnostic. When a single or double bit error is detected the Master R4F is notified via ESM (Error Signaling Module). This feature is disabled after reset. Software must configure and enable this feature in the peripheral and ESM module. ECC failure (both single bit corrected and double bit uncorrectable error conditions) is reported to the Master R4F as an interrupt via ESM module.
11	Configuration registers protection for Master SS peripherals	All the Master SS peripherals (SPIs, CANs, I2C, DMAs, RTI/WD, DCCs, IOMUX etc.) are connected to interconnect via Peripheral Central resource (PCR). This provides two diagnostic mechanisms that can limit access to peripherals. Peripherals can be clock gated per peripheral chip select in the PCR. This can be utilized to disable unused features such that they cannot interfere. In addition, each peripheral chip select can be programmed to limit access based on privilege level of transaction. This feature can be used to limit access to entire peripherals to privileged operating system code only. These diagnostic mechanisms are disabled after reset. Software must configure and enable these mechanisms. Protection violation also generates an 'aerror' that result in abort to Master R4F or error response to other masters such as DMAs.
12	Cyclic Redundancy Check – Master SS	<ul> <li>Device architecture supports hardware CRC engine on Master SS implementing the below polynomials.</li> <li>CRC16 CCITT – 0x10</li> <li>CRC32 Ethernet – 0x04C11DB7</li> <li>CRC64</li> <li>CRC 32C – CASTAGNOLI – 0x1EDC6F4</li> <li>CRC32P4 – E2E Profile4 – 0xF4ACFB1</li> <li>CRC-8 – H2F Autosar – 0x2F</li> <li>CRC-8 – VDA CAN – 0x1D</li> <li>The read operation of the SRAM contents to the CRC can be done by CPU or by DMA. The comparison of results, indication of fault, and fault response are the responsibility of the software managing the test.</li> </ul>
13	MPU for DMAs	Device architecture supports MPUs on Master SS DMAs. Failure detection by MPU is reported to the Master R4F CPU core as an interrupt via ESM. DSPSS's high performance EDMAs also includes MPUs on both read and writes master ports. EDMA MPUs supports 8 regions. Failure detection by MPU is reported to the DSP core as an interrupt via local ESM.



#### Table 9-1. Monitoring and Diagnostic Mechanisms for Functional Safety-Compliant Targeted Devices (continued)

NO	FEATURE	(continued) DESCRIPTION
14	Boot time LBIST For BIST R4F Core and associated VIM	Device architecture supports hardware logic BIST (LBIST) even for BIST R4F core and associated VIM module. This logic provides very high diagnostic coverage (>90%) on the BIST R4F CPU core and VIM. This is triggered by Master R4F boot loader at boot time and it does not proceed further if the fault is detected.
15	Boot time PBIST for BIST R4F TCM Memories	Device architecture supports a hardware programmable memory BIST (PBIST) engine for BIST R4F TCMs which provide a very high diagnostic coverage (March-13n) on the BIST R4F TCMs. PBIST is triggered by Master R4F Bootloader at the boot time and it does not proceed further if the fault is detected.
16	End to End ECC for BIST R4F TCM Memories	BIST R4F TCMs diagnostic is supported by Single error correction double error detection (SECDED) ECC diagnostic. Single bit error is communicated to the BIST R4FCPU while double bit error is communicated to Master R4F as an interrupt so that application code becomes aware of this and takes appropriate action.
17	BIST R4F TCM bit multiplexing	Logical TCM word and its associated ECC code is split and stored in two physical SRAM banks. This scheme provides an inherent diagnostic mechanism for address decode failures in the physical SRAM banks and helps to reduce the probability of physical multi-bit faults resulting in logical multi-bit faults.
18	RTI/WD for BIST R4F	Device architecture supports an internal watchdog for BIST R4F. Timeout condition is reported via an interrupt to Master R4F and rest is left to application code to either go for SW reset for BIST SS or warm reset for the device to come out of faulty condition.
19	Boot time PBIST for L1P, L1D, L2 and L3 Memories	Device architecture supports a hardware programmable memory BIST (PBIST) engine for DSPSS's L1P, L1D, L2 and L3 memories which provide a very high diagnostic coverage (March-13n). PBIST is triggered by Master R4F Bootloader at the boot time and it does not proceed further if the fault is detected.
20	Parity on L1P	Device architecture supports Parity diagnostic on DSP's L1P memory. Parity error is reported to the CPU as an interrupt. Note:- L1D memory is not covered by parity or ECC and need to be covered by application level diagnostics.
21	ECC on DSP's L2 Memory	Device architecture supports both Parity Single error correction double error detection (SECDED) ECC diagnostic on DSP's L2 memory. L2 Memory is a unified 256KB of memory used to store program and Data sections for the DSP. A 12-bit code word is used to store the ECC data as calculated over the 256-bit data bus (logical instruction fetch size). The ECC logic for the L2 access is located in the DSP and evaluation is done by the ECC control logic inside the DSP. This scheme provides end-to-end diagnostics on the transmissions between DSP and L2. Byte aligned Parity mechanism is also available on L2 to take care of data section.
22	ECC on Radar Data Cube (L3) Memory	L3 memory is used as Radar data section in Device. Device architecture supports Single error correction double error detection (SECDED) ECC diagnostic on L3 memory. An 8-bit code word is used to store the ECC data as calculated over the 64-bit data bus. Failure detection by ECC logic is reported to the Master R4F CPU core as an interrupt via ESM.
23	RTI/WD for DSP Core	Device architecture supports the use of an internal watchdog for BIST R4F that is implemented in the real-time interrupt (RTI) module – replication of same module as used in Master SS. This module supports same features as that of RTI/WD for Master/BIST R4F. This watchdog is enabled by customer application code and Timeout condition is reported via an interrupt to Master R4F and rest is left to application code in Master R4F to either go for SW reset for DSP SS or warm reset for the device to come out of faulty condition.
24	CRC for DSP Sub-System	<ul> <li>Device architecture supports dedicated hardware CRC on DSPSS implementing the below polynomials.</li> <li>CRC16 CCITT - 0x10</li> <li>CRC32 Ethernet - 0x04C11DB7</li> <li>CRC64</li> <li>The read of SRAM contents to the CRC can be done by DSP CPU or by DMA. The comparison of results, indication of fault, and fault response are the responsibility of the software managing the test.</li> </ul>



#### Table 9-1. Monitoring and Diagnostic Mechanisms for Functional Safety-Compliant Targeted Devices (continued)

NO	FEATURE	DESCRIPTION
25	MPU for DSP	Device architecture supports MPUs for DSP memory accesses (L1D, L1P, and L2). L2 memory supports 64 regions and 16 regions for L1P and L1D each. Failure detection by MPU is reported to the DSP core as an abort.
26	Temperature Sensors	Device architecture supports various temperature sensors all across the device (next to power hungry modules such as PAs, DSP etc) which is monitored during the inter-frame period. <sup>(1)</sup>
27	Tx Power Monitors	Device architecture supports power detectors at the Tx output. <sup>(2)</sup>
28	Error Signaling Error Output	When a diagnostic detects a fault, the error must be indicated. The device architecture provides aggregation of fault indication from internal monitoring/diagnostic mechanisms using a peripheral logic known as the Error Signaling Module (ESM). The ESM provides mechanisms to classify errors by severity and to provide programmable error response. ESM module is configured by customer application code and specific error signals can be enabled or masked to generate an interrupt (Low/High priority) for the Master R4F CPU. Device supports Nerror output signal (IO) which can be monitored externally to identify any kind of high severity faults in the design which could not be handled by the R4F.
29	Synthesizer (Chirp) frequency monitor	Monitors Synthesizer's frequency ramp by counting (divided-down) clock cycles and comparing to ideal frequency ramp. Excess frequency errors above a certain threshold, if any, are detected and reported.
30	Ball break detection for TX ports (TX Ball break monitor)	Device architecture supports a ball break detection mechanism based on Impedance measurement at the TX output(s) to detect and report any large deviations that can indicate a ball break. Monitoring is done by TIs code running on BIST R4F and failure is reported to the Master R4F via Mailbox. It is completely up to customer SW to decide on the appropriate action based on the message from BIST R4F.
31	RX loopback test	Built-in TX to RX loopback to enable detection of failures in the RX path(s), including Gain, inter-RX balance, etc.
32	IF loopback test	Built-in IF (square wave) test tone input to monitor IF filter's frequency response and detect failure.
33	RX saturation detect	Provision to detect ADC saturation due to excessive incoming signal level and/or interference.
34	Boot time LBIST for DSP core	Device device supports boot time LBIST for the DSP Core. LBIST can be triggered by the Master R4F application code during boot time.

(1) Monitoring is done by the TI's code running on BIST R4F. There are two modes in which it could be configured to report the temperature sensed via API by customer application.

- a. Report the temperature sensed after every N frames
- b. Report the condition once the temperature crosses programmed threshold.

It is completely up to customer SW to decide on the appropriate action based on the message from BIST R4Fvia Mailbox. (2) Monitoring is done by the TI's code running on BIST R4F.

There are two modes in which it could be configured to report the detected output power via API by customer application.

- a. Report the power detected after every N frames
- b. Report the condition once the output power degrades by more than configured threshold from the configured.

It is completely up to customer SW to decide on the appropriate action based on the message from BIST R4F.



#### 9.1.1 Error Signaling Module

When a diagnostic detects a fault, the error must be indicated. architecture provides aggregation of fault indication from internal diagnostic mechanisms using a peripheral logic known as the error signaling module (ESM). The ESM provides mechanisms to classify faults by severity and allows programmable error response. Below is the high level block diagram for ESM module.

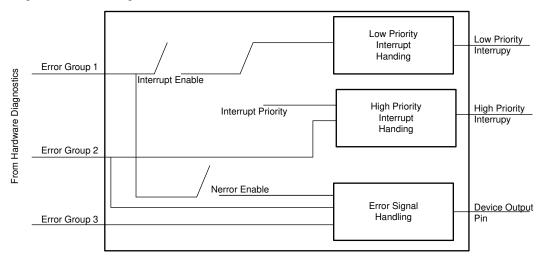


Figure 9-1. ESM Module Diagram



## 10 Applications, Implementation, and Layout

#### Note

Information in the following Applications section is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

#### **10.1 Application Information**

Application information can be found on AWR Application web page.

#### **10.2 Reference Schematic**

Please check the device product page for latest Hardware design information under Design Kits - typically, at Design & development.

Listed for convenience are: Design Files, Schematics, Layouts, and Stack up for PCB.

- Altium XWR6843 EVM Design Files
- XWR6843 EVM Schematic Drawing, Assembly Drawing, and Bill of Materials



## **11 Device and Documentation Support**

TI offers an extensive line of development tools. Tools and software to evaluate the performance of the device, generate code, and develop solutions follow.

#### **11.1 Device Nomenclature**

To designate the stages in the product development cycle, TI assigns prefixes to the part numbers of all microprocessors (MPUs) and support tools. Each device has one of three prefixes: X, P, or null (no prefix) (for example, *AWR6843*). Texas Instruments recommends two of three possible prefix designators for its support tools: TMDX and TMDS. These prefixes represent evolutionary stages of product development from engineering prototypes (TMDX) through fully qualified production devices and tools (TMDS).

Device development evolutionary flow:

- **XA** Experimental device that is not necessarily representative of the final device's electrical specifications and may not use production assembly flow.
- **P** Prototype device that is not necessarily the final silicon die and may not necessarily meet final electrical specifications.

**null** Production version of the silicon die that is fully qualified.

Support tool development evolutionary flow:

**TMDX** Development-support product that has not yet completed Texas Instruments internal qualification testing.

**TMDS** Fully-qualified development-support product.

XA and P devices and TMDX development-support tools are shipped against the following disclaimer:

"Developmental product is intended for internal evaluation purposes."

Production devices and TMDS development-support tools have been characterized fully, and the quality and reliability of the device have been demonstrated fully. TI's standard warranty applies.

Predictions show that prototype devices (XA or P) have a greater failure rate than the standard production devices. Texas Instruments recommends that these devices not be used in any production system because their expected end-use failure rate still is undefined. Only qualified production devices are to be used.

TI device nomenclature also includes a suffix with the device family name. This suffix indicates the package type (for example, ABL0161), the temperature range (for example, blank is the default automotive temperature range). Figure 11-1 provides a legend for reading the complete device name for any *AWR6843* device.

For orderable part numbers of *AWR6843* devices in the ABL0161 package types, see the Package Option Addendum of this document, the TI website (<u>www.ti.com</u>),or contact your TI sales representative.

For additional description of the device nomenclature markings on the die, see the *xWR6843 Device Errata*.

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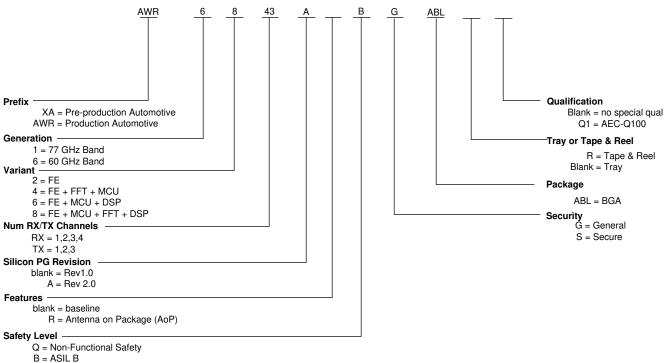


Figure 11-1. Device Nomenclature

#### 11.2 Tools and Software

#### Models

xWR6843 BSDL model	Boundary scan database of testable input and output pins for IEEE 1149.1 of the specific device.
xWR6843 IBIS model	IO buffer information model for the IO buffers of the device. For simulation on a circuit board, see IBIS Open Forum.
xWR6843 checklist for schematic review, layout review,bringup/wakeup	A set of steps in spreadsheet form to select system functions and pinmux options. Specific EVM schematic and layout notes to apply to customer engineering. A bring up checklist is suggested for customers.

#### **11.3 Documentation Support**

To receive notification of documentation updates—including silicon errata—go to the product folder for your device on ti.com (AWR6843). In the upper right corner, click the "Alert me" button. This registers you to receive a weekly digest of product information that has changed (if any). For change details, check the revision history of any revised document.

The current documentation that describes the DSP, related peripherals, and other technical collateral follows.

#### Errata

xWR6843 Device Errata Describes known advisories, limitations, and cautions on silicon and provides workarounds.

#### **11.4 Support Resources**

TI E2E<sup>™</sup> support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.



## 11.5 Trademarks

TI E2E<sup>™</sup> is a trademark of Texas Instruments.

ARM<sup>®</sup> and Cortex<sup>®</sup> are registered trademarks of ARM Limited. All other trademarks are the property of their respective owners.

## 11.6 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

#### 11.7 Glossary

**TI Glossary** This glossary lists and explains terms, acronyms, and definitions.



## 12 Mechanical, Packaging, and Orderable Information

## 12.1 Packaging Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

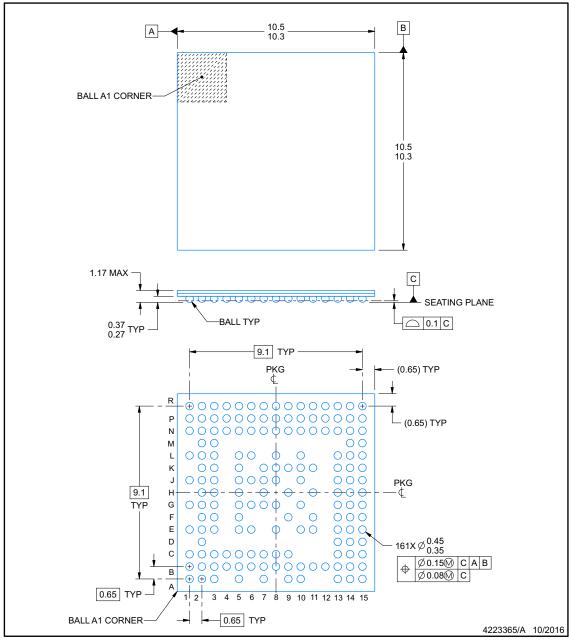


**ABL0161B** 

## PACKAGE OUTLINE

#### FCBGA - 1.17 mm max height

PLASTIC BALL GRID ARRAY



NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing

per ASME Y14.5M.2. This drawing is subject to change without notice.

www.ti.com

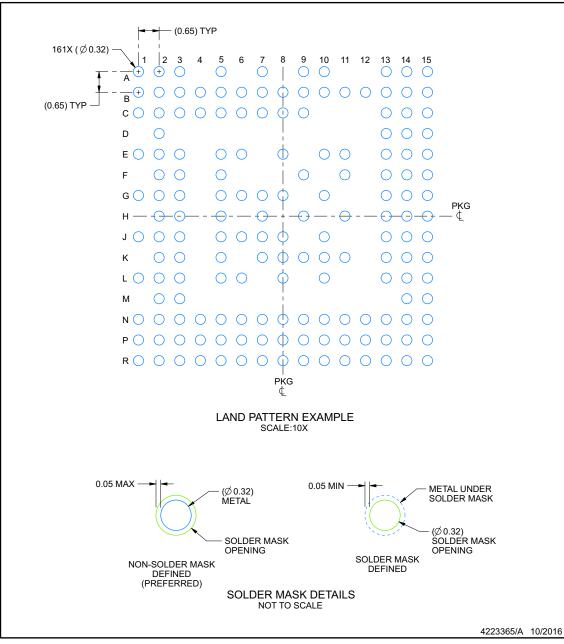
**ABL0161B** 



## EXAMPLE BOARD LAYOUT

FCBGA - 1.17 mm max height

PLASTIC BALL GRID ARRAY



NOTES: (continued)

3. Final dimensions may vary due to manufacturing tolerance considerations and also routing constraints. For information, see Texas Instruments literature number SPRAA99 (www.ti.com/lit/spraa99).

www.ti.com

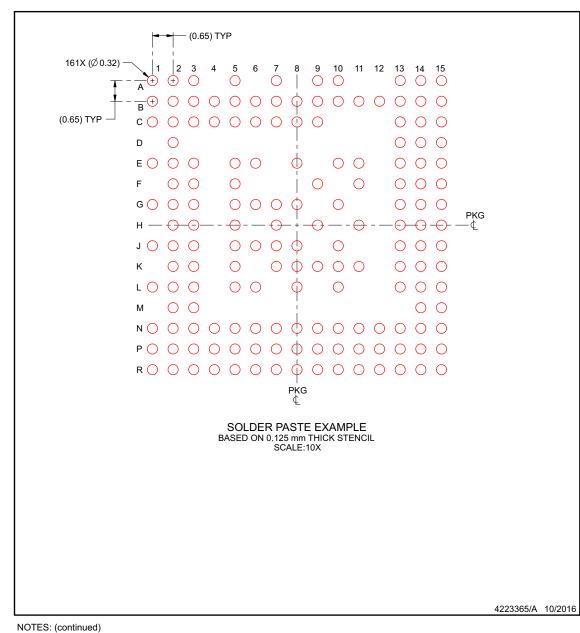


**ABL0161B** 

## **EXAMPLE STENCIL DESIGN**

FCBGA - 1.17 mm max height

PLASTIC BALL GRID ARRAY

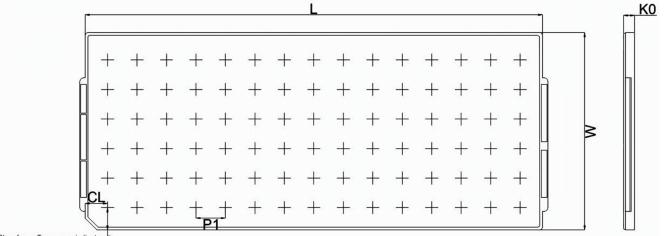


4. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release.

www.ti.com



#### 12.2 Tray Information for ABL, 10.4 × 10.4 mm



Chamfer on Tray corner indicates Pin 1 orientation of packed units

Device	Package Type	Package Name	Pins	SPQ	Unit Array Matrix	Max Temp. (°C)	L (mm)	W (mm)	K0 (mm)	P1 (mm)	CL (mm)	CW (mm)
AWR6843AQGABLQ1	FC/CSP	ABL	161	176	8 × 22	150	315.0	135.9	7.62	13.40	16.80	17.20
AWR6843ABGABLQ1	FC/CSP	ABL	161	176	8 × 22	150	315.0	135.9	7.62	13.40	16.80	17.20



10-Dec-2020

## PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
AWR6843ABGABLQ1	ACTIVE	FC/CSP	ABL	161	176	RoHS & Green	SNAGCU	Level-3-260C-168 HR	-40 to 125	AWR6843 BG 678A 678A ABL	Samples
AWR6843ABGABLRQ1	ACTIVE	FC/CSP	ABL	161	1000	RoHS & Green	SNAGCU	Level-3-260C-168 HR	-40 to 125	AWR6843 BG 678A 678A ABL	Samples
AWR6843ABSABLQ1	ACTIVE	FC/CSP	ABL	161	176	RoHS & Green	SNAGCU	Level-3-260C-168 HR	-40 to 125	AWR6843 BS 678A 678A ABL	Samples
AWR6843ABSABLRQ1	ACTIVE	FC/CSP	ABL	161	1000	RoHS & Green	SNAGCU	Level-3-260C-168 HR	-40 to 125	AWR6843 BS 678A 678A ABL	Samples
AWR6843AQGABLQ1	ACTIVE	FC/CSP	ABL	161	176	RoHS & Green	SNAGCU	Level-3-260C-168 HR	-40 to 125	AWR6843 QG 678A 678A ABL	Samples
AWR6843AQGABLRQ1	ACTIVE	FC/CSP	ABL	161	1000	RoHS & Green	SNAGCU	Level-3-260C-168 HR	-40 to 125	AWR6843 QG 678A 678A ABL	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.



## PACKAGE OPTION ADDENDUM

10-Dec-2020

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

<sup>(5)</sup> Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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## PACKAGE MATERIALS INFORMATION

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### TAPE AND REEL INFORMATION



\*All dimensions are nominal



## QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
AWR6843ABGABLRQ1	FC/CSP	ABL	161	1000	330.0	24.4	10.7	10.7	1.65	16.0	24.0	Q1
AWR6843AQGABLRQ1	FC/CSP	ABL	161	1000	330.0	24.4	10.7	10.7	1.65	16.0	24.0	Q1

TEXAS INSTRUMENTS

www.ti.com

## PACKAGE MATERIALS INFORMATION

16-Oct-2020



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
AWR6843ABGABLRQ1	FC/CSP	ABL	161	1000	336.6	336.6	41.3
AWR6843AQGABLRQ1	FC/CSP	ABL	161	1000	336.6	336.6	41.3

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